



Indian Agricultural Research Institute
भारतीय कृषि अनुसंधान संस्थान
(An ISO 9001:2008 Certified Institute)



50 Years of Remote Sensing in India



Wheat Yield Mapping and Prediction: Empirical to Simulation Modelling using RS

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<http://creams.iari.res.in>

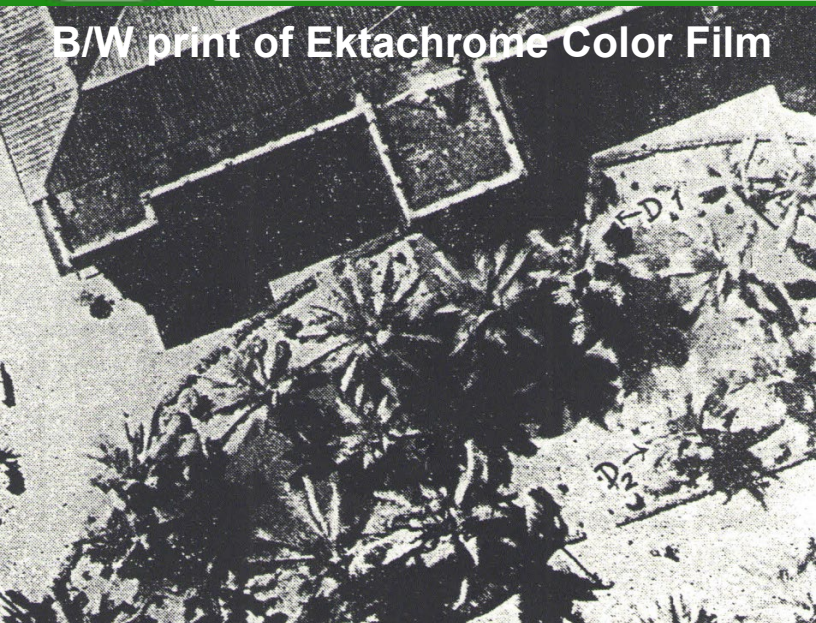




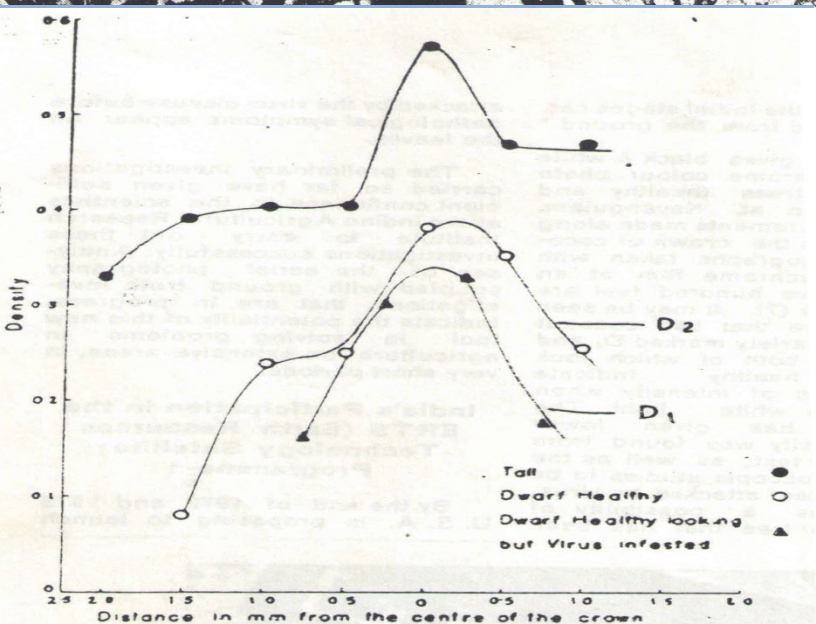
First RS Expt in India Coconut Root Wilt Disease Detection



B/W print of Ektachrome Color Film



Aerial view of grove area



Experimental Details:

- NASA-ISRO-IARI-CCRS Collaboration
- 1969-70
- CRW disease caused by virus
- Aim to identify diseased pockets and intensity of disease to check its spread
- Multi-band images acquired at 500 & 1000 feet from an helicopter
- Distinguished diseased palms from healthy
- Distinguished one species from another
- **Possibility of identifying infected palms before pathological symptoms appear**



Contents



- ❑ **Need for Yield Mapping and Prediction**
 - **For food security planning**
 - **For crop insurance payouts**
- ❑ **Approaches of yield modelling by Satellite Images**
 - ❑ **Historical Yields**
 - **Generate synthetic yield series**
 - **Spatial disaggregation of yield statistics**
 - ❑ **In-season Yields**
 - **Empirical : Single / Multi-date RS**
 - **Linking RS with Dynamic Crop Models**
- ❑ **Operational System – Convergence of Evidence**



Why Remote Sensing for Crop Yield Modeling?



PROS

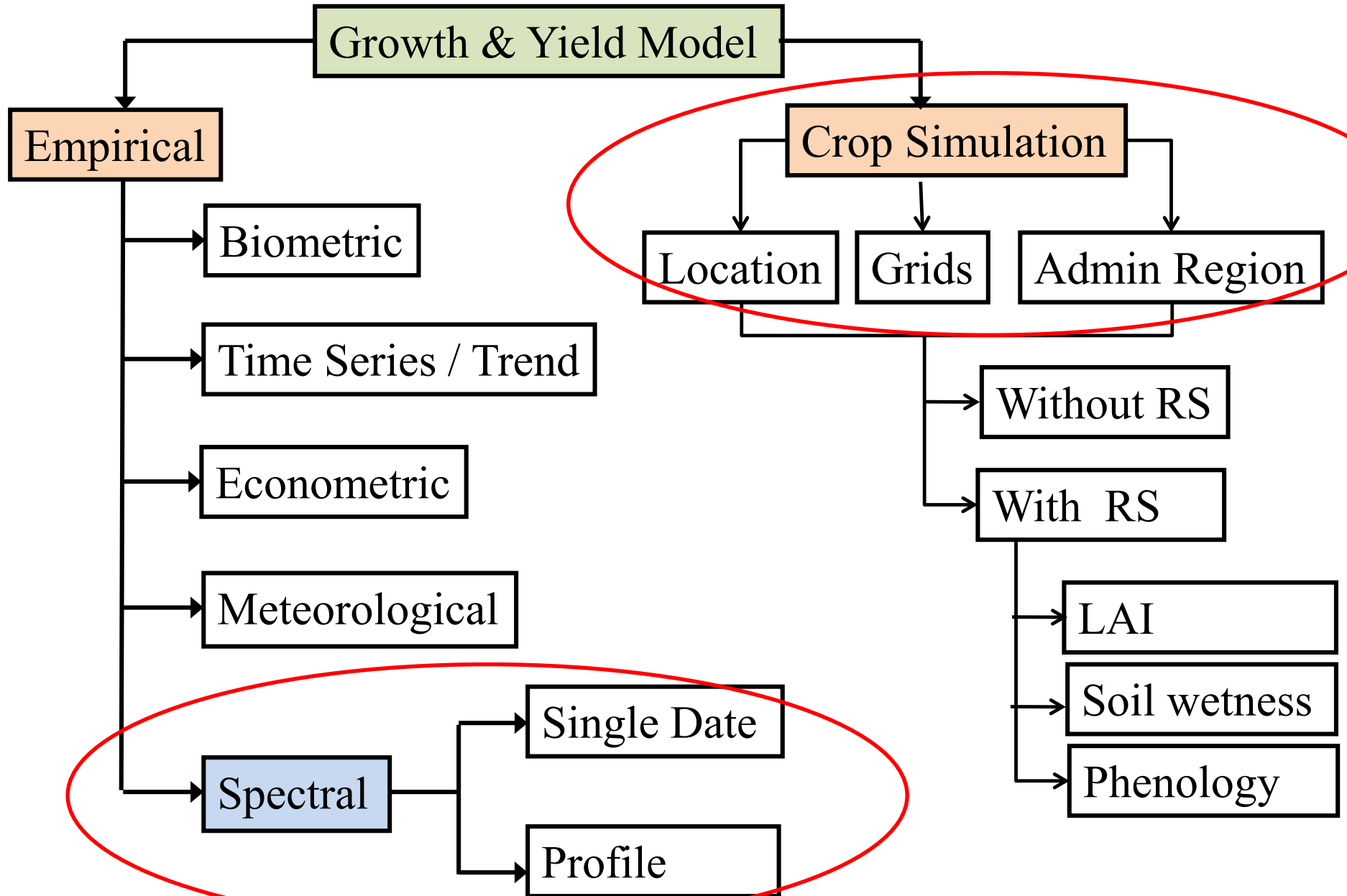
- Range of Spatial / Spectral Resolutions – field scale to regional scale
- Repetitive – for regular monitoring
- Indices directly observe crop vigour – sound scientific basis
- Observe crop environment – Rainfall, Temperature, Soil moisture, ...
- Digital – amenable to computer algorithms, objectivity, sharing, storage
- Low cost per unit area
- Multiple sources and historical standardized datasets

CONS

- Not directly measure crop yield
- Difficult to observe crop during early growth stages
- Greenness / vigour and yield may be poorly related for some crops
- Crop signatures are not unique - Heterogeneity
- Noise in data – viewing condition, cloud cover, haze
- Specialized software and analyst requirement



Broad Yield Modeling Approaches

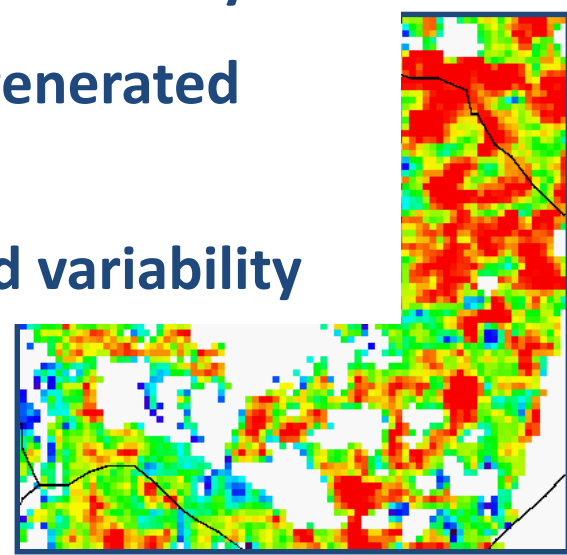
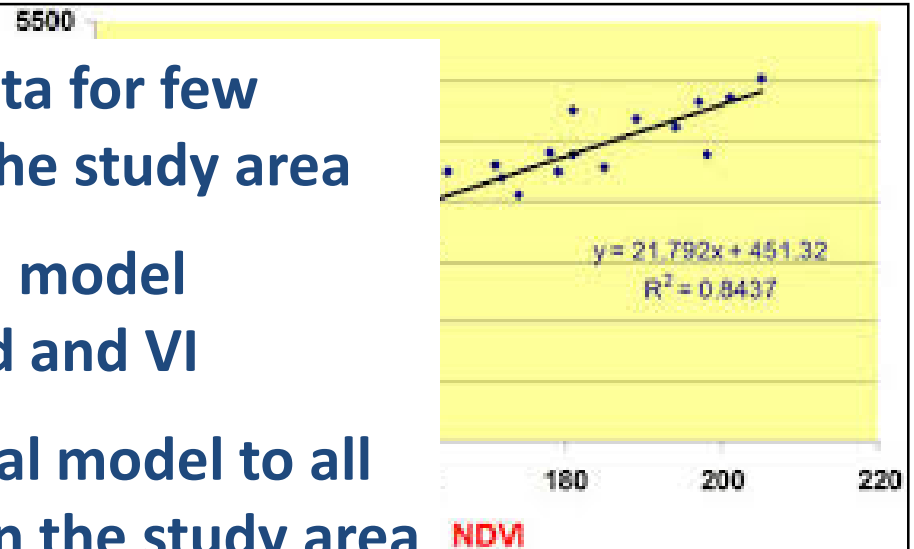




Empirical Single Date Model Wheat



- Need CCE yield data for few selected plots in the study area
- Develop empirical model between CCE yield and VI
- Apply the empirical model to all other crop fields in the study area
- Model need to be generated every year
- 20-30% unexplained variability



GRAIN YIELD (t/ha)

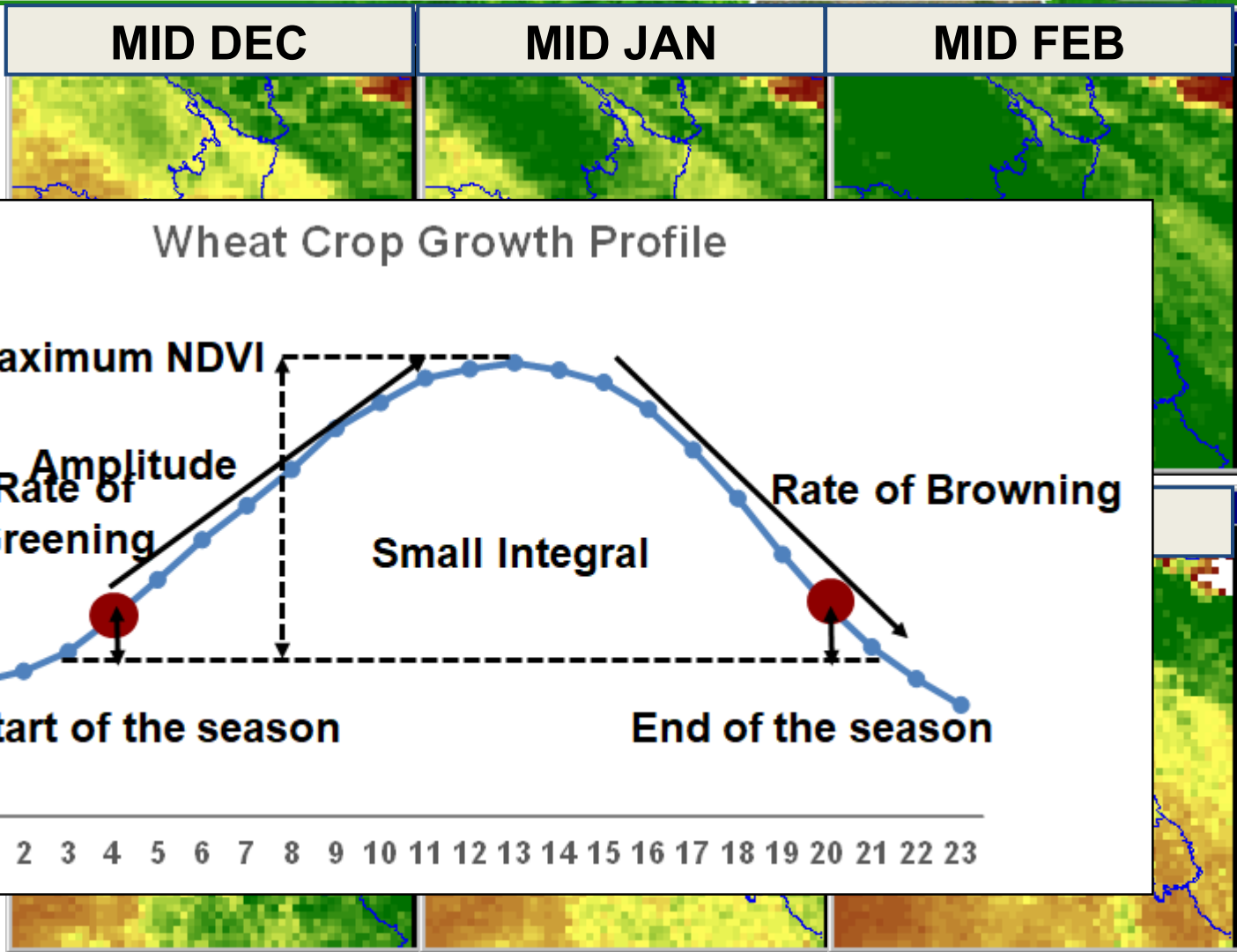
2.1 3.5 4.8



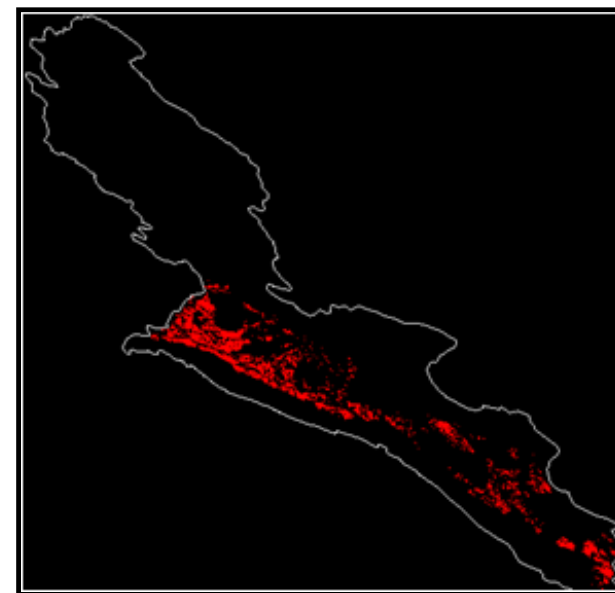
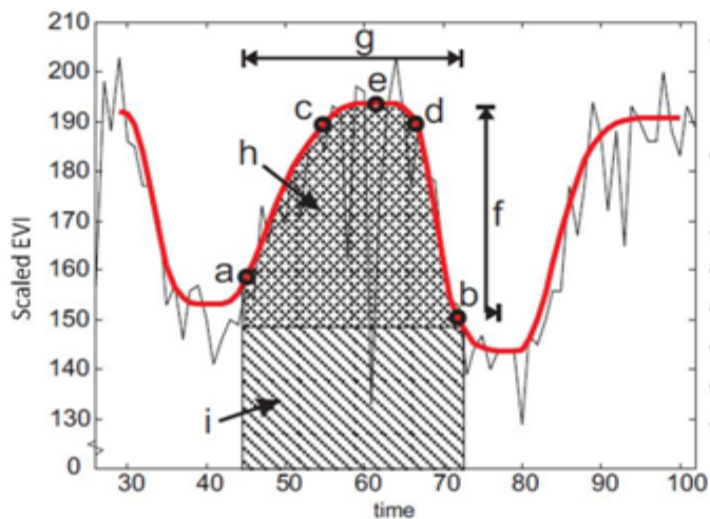
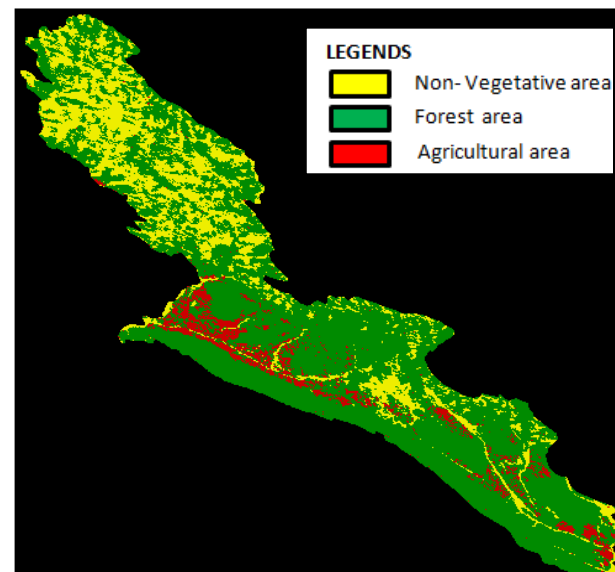
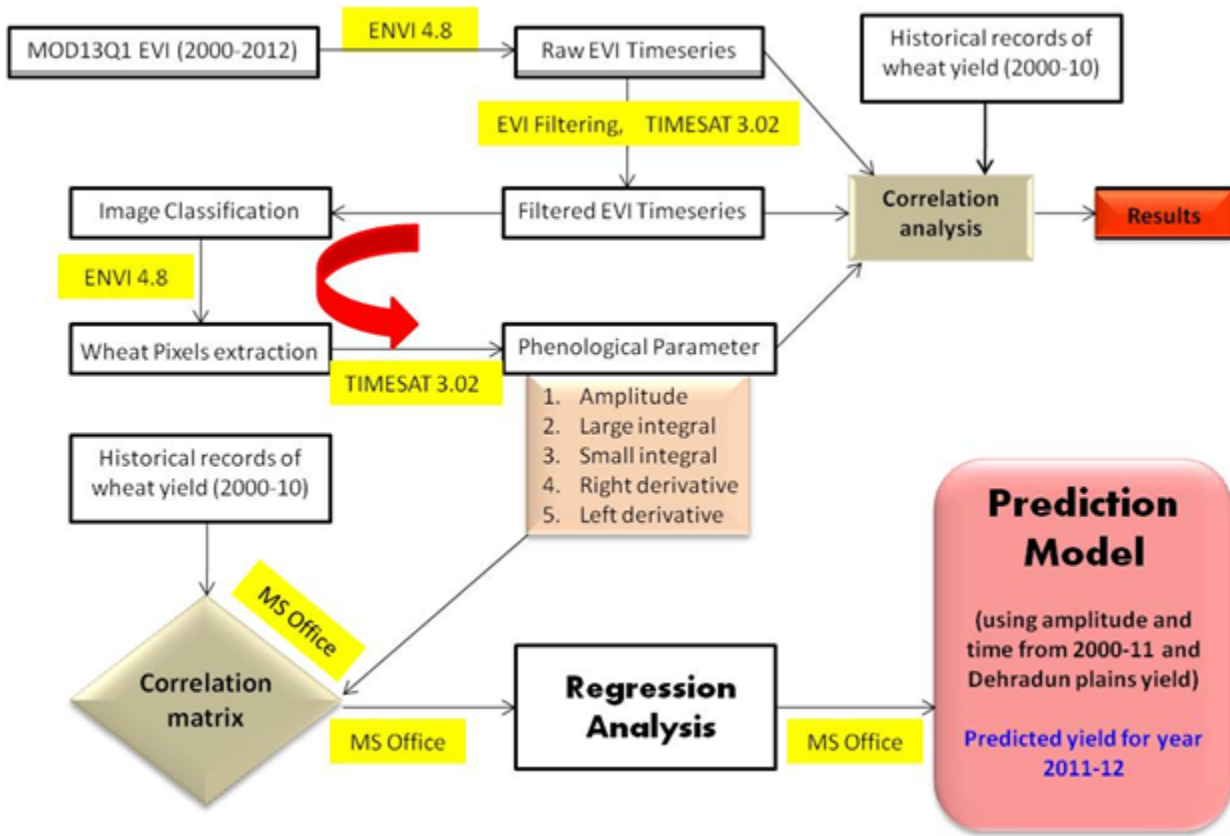
Empirical Multi Date Model : Wheat



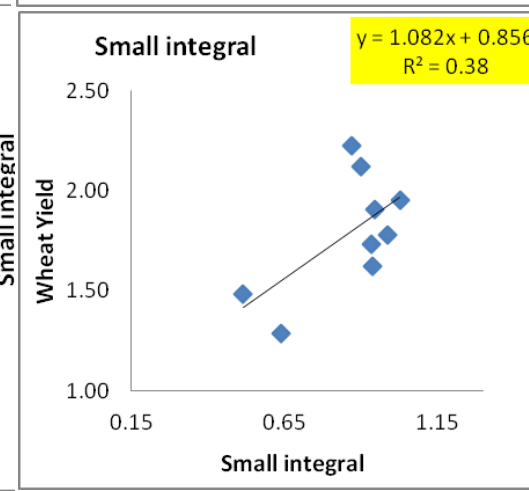
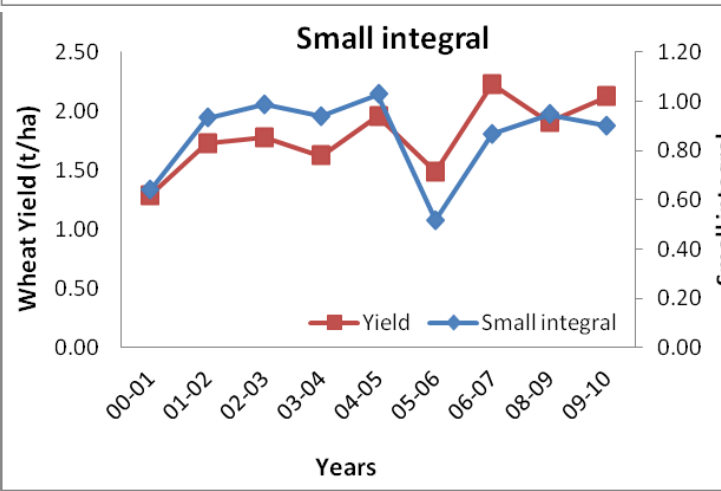
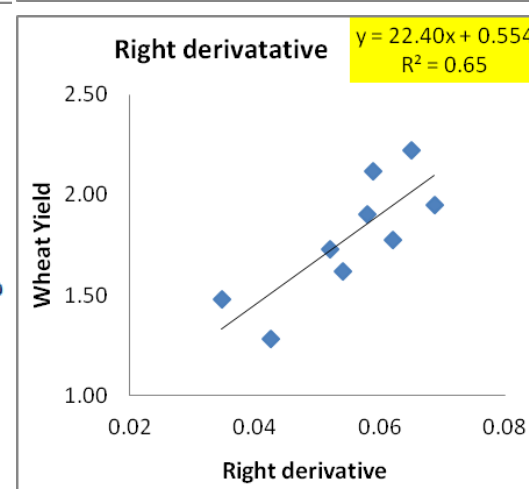
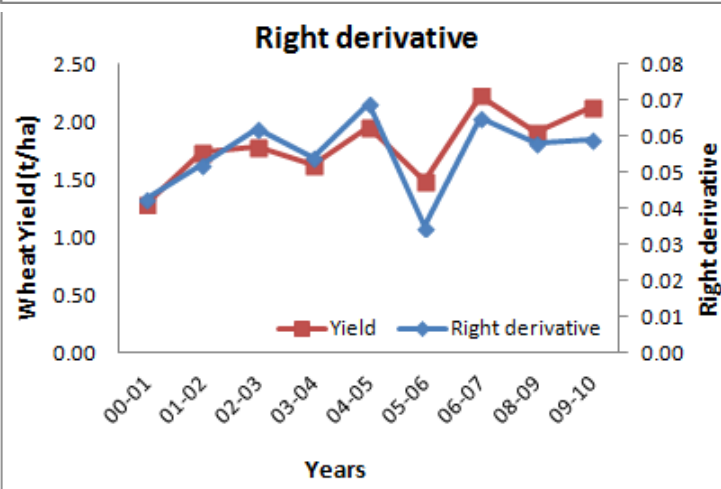
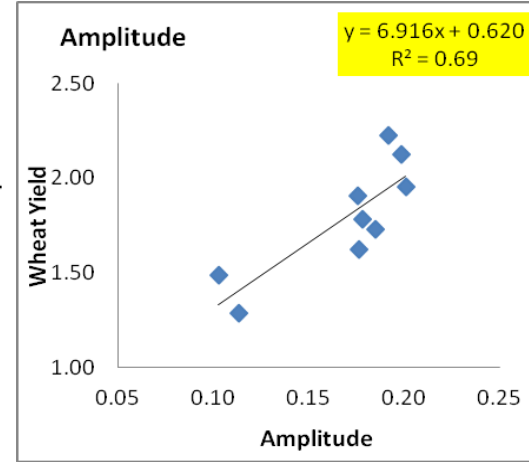
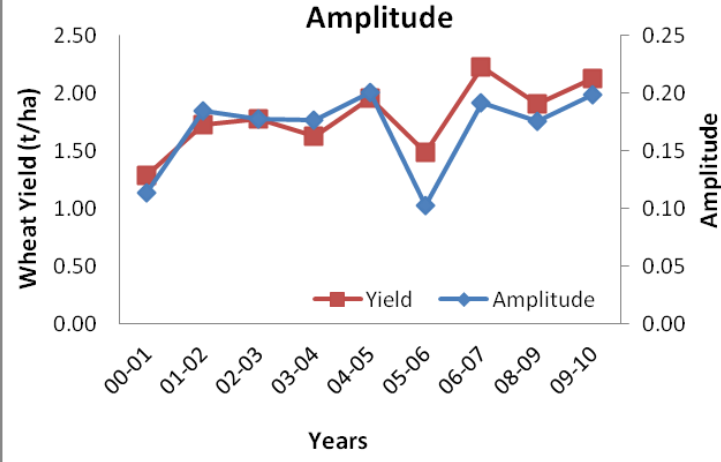
- Use moderate to coarse resolution images
- Higher revisi satellite
- Need to filter RS data for n
- Fit a growth model
- Derive param from profile
- The param shows integr seasonal growth
- Better relate to yield



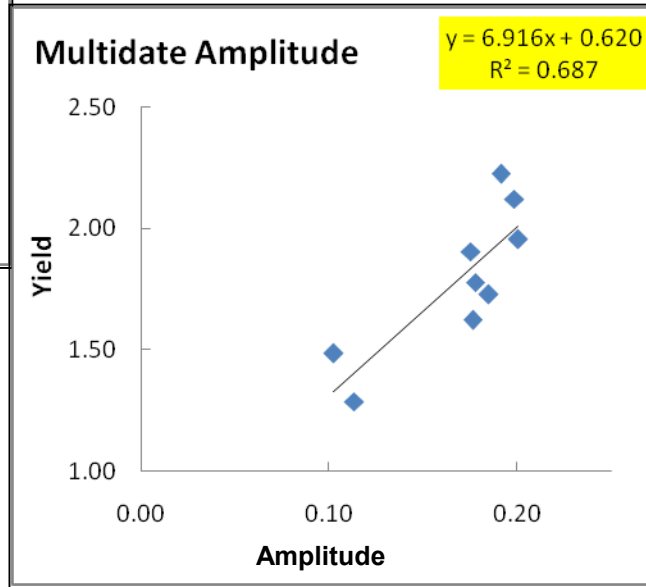
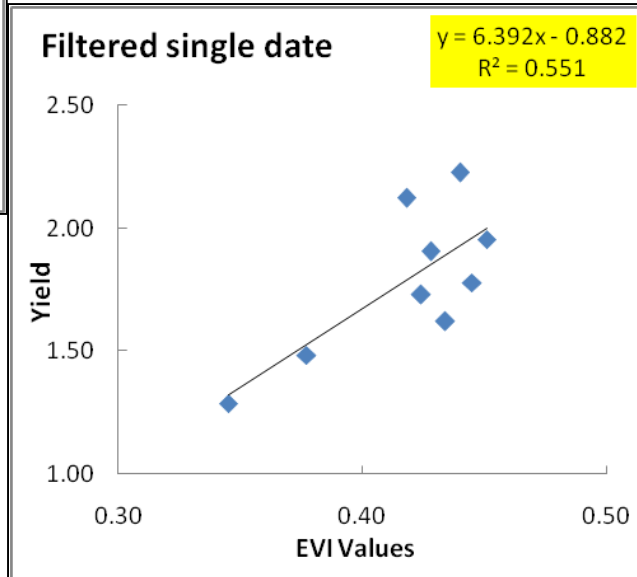
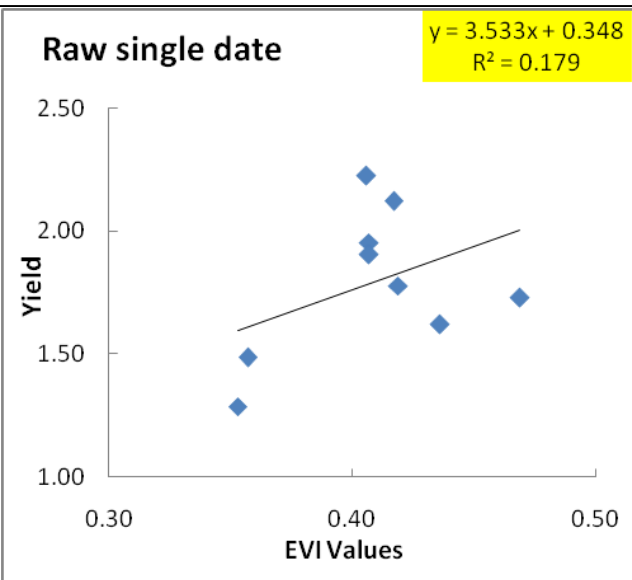
Wheat Crop Yield Modeling



Dehradun District



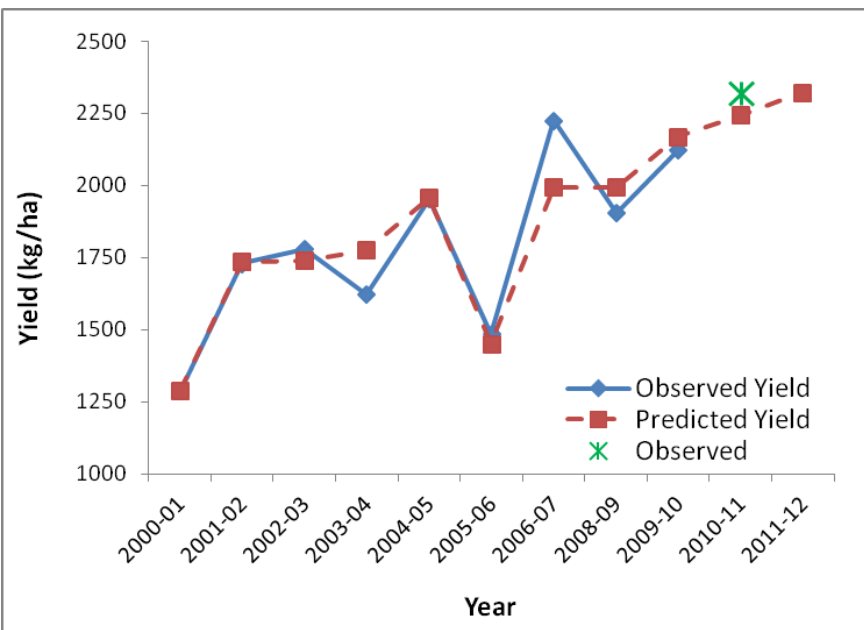
Comparison between single date raw, filtered and multi-date phenology derived parameter



Performance of Crop Yield Model

$$\text{Yield} = 607.23 + 5614.9 * \text{Amplitude} + 44.72 * \text{Time}$$

(Adj R² = 0.83 (p=0.002), SE = 123.0)



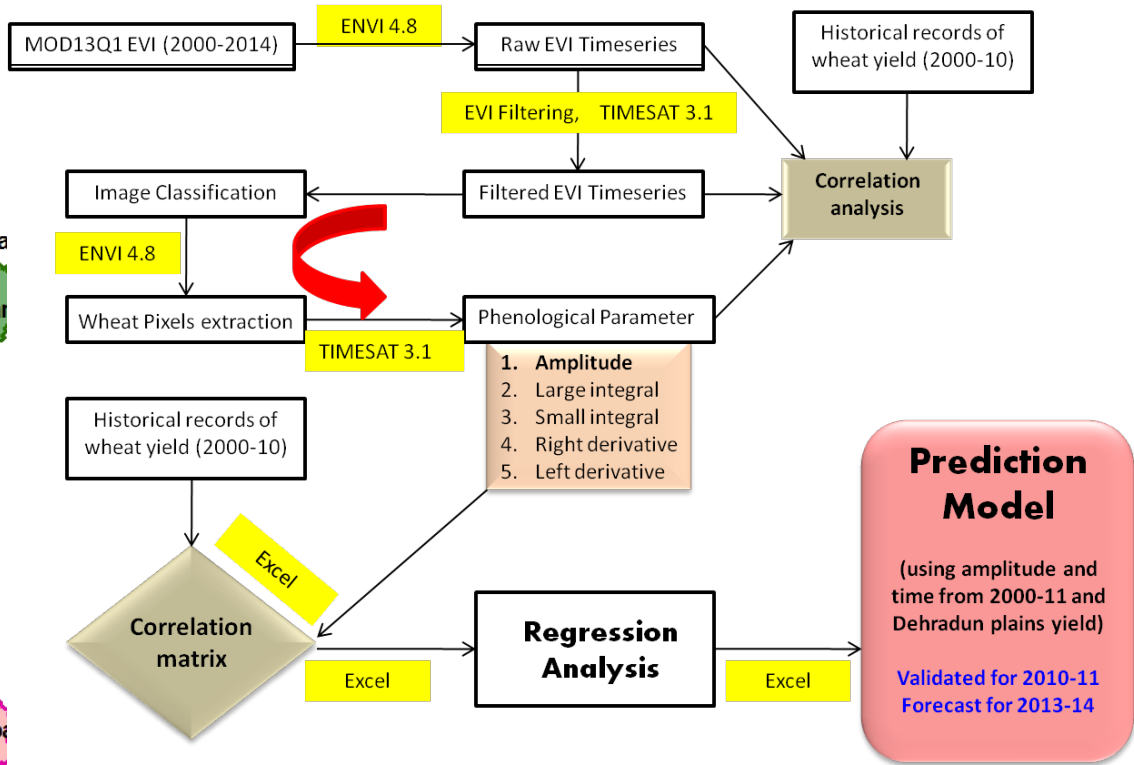
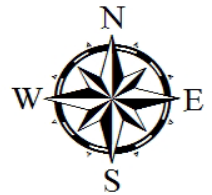
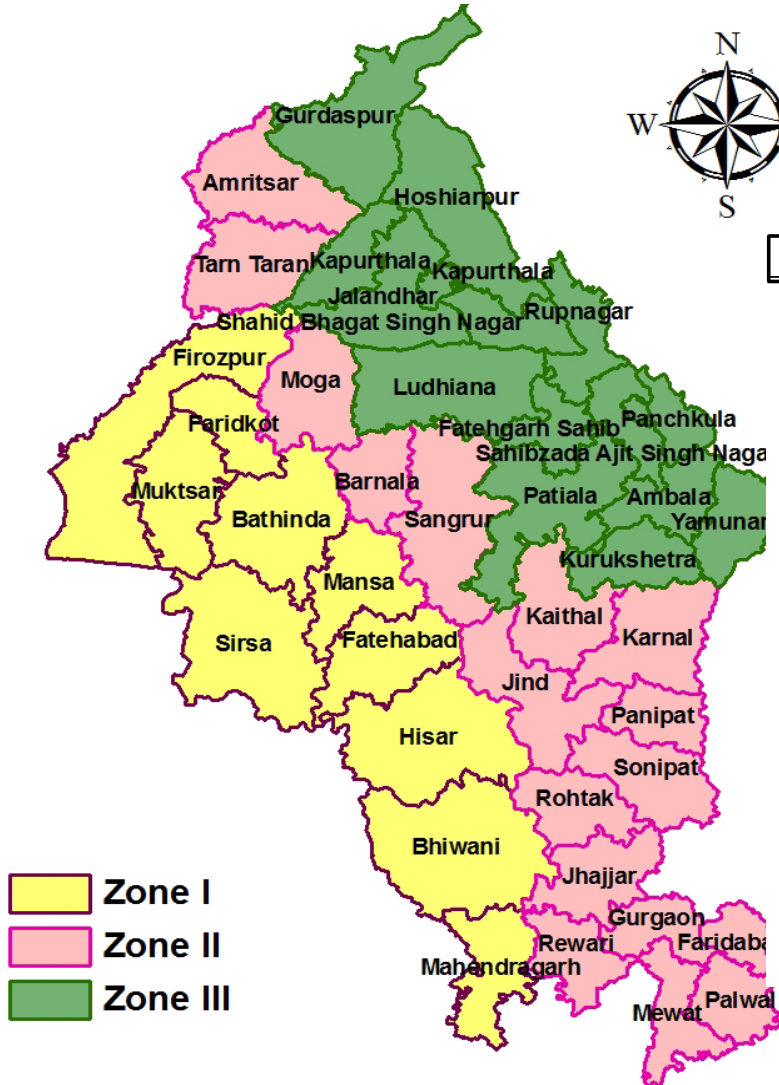
S. No.	Year	DAC Yield (kg/ha)	Amplitude	Time	Predicted Yield (kg/ha)	Relative Deviation (%)
1	2000-01	1287.1	0.11	1	1289.0	0.15
2	2001-02	1729.6	0.19	2	1735.4	0.34
3	2002-03	1779.2	0.18	3	1740.3	-2.19
4	2003-04	1621.4	0.18	4	1776.6	9.57
5	2004-05	1954.0	0.20	5	1957.8	0.19
6	2005-06	1484.8	0.10	6	1450.5	-2.31
7	2006-07	2226.4	0.19	7	1995.0	-10.39
9	2008-09	1904.4	0.18	9	1994.6	4.74
10	2009-10	2121.8	0.20	10	2169.6	2.25
11	2010-11	---	0.20	11	2244.7	---
12	2011-12	---	0.21	12	2323.1	---



Wheat Yield Forecasting – Group of Districts

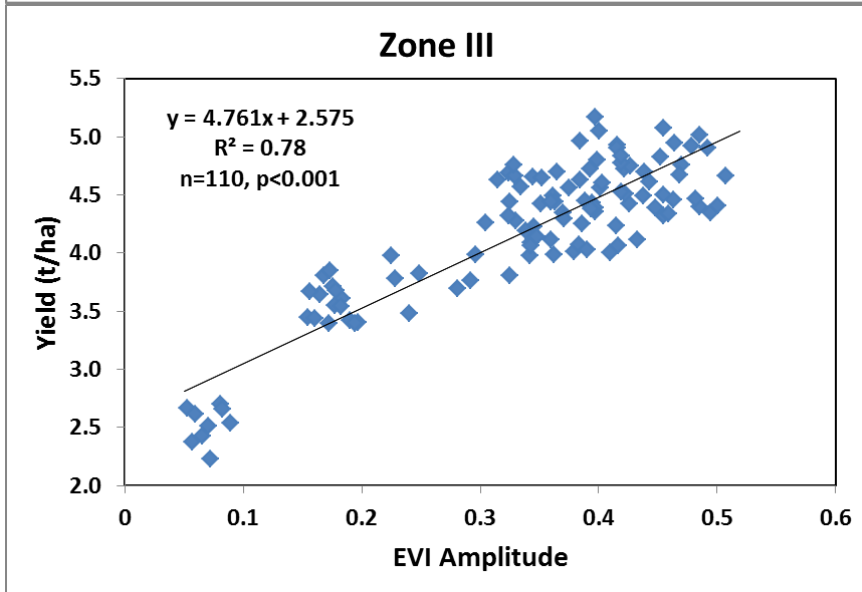
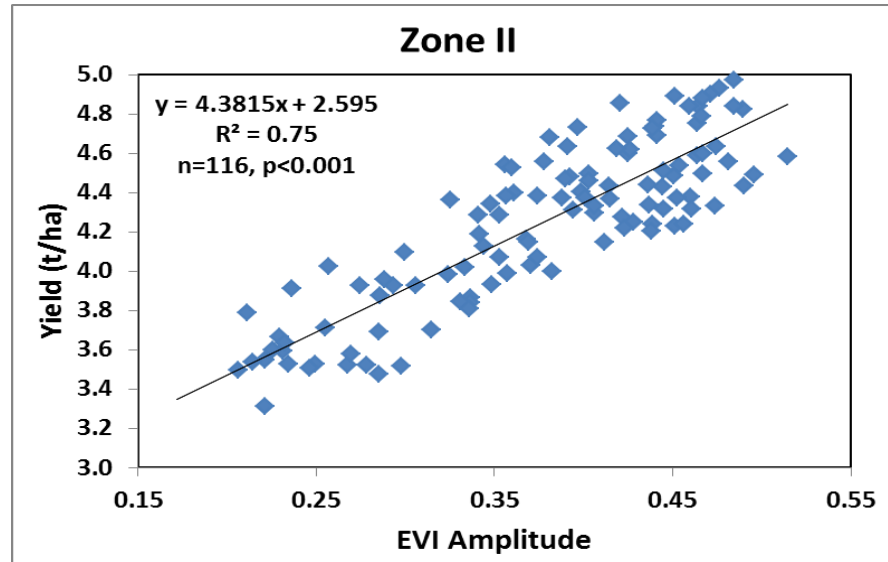
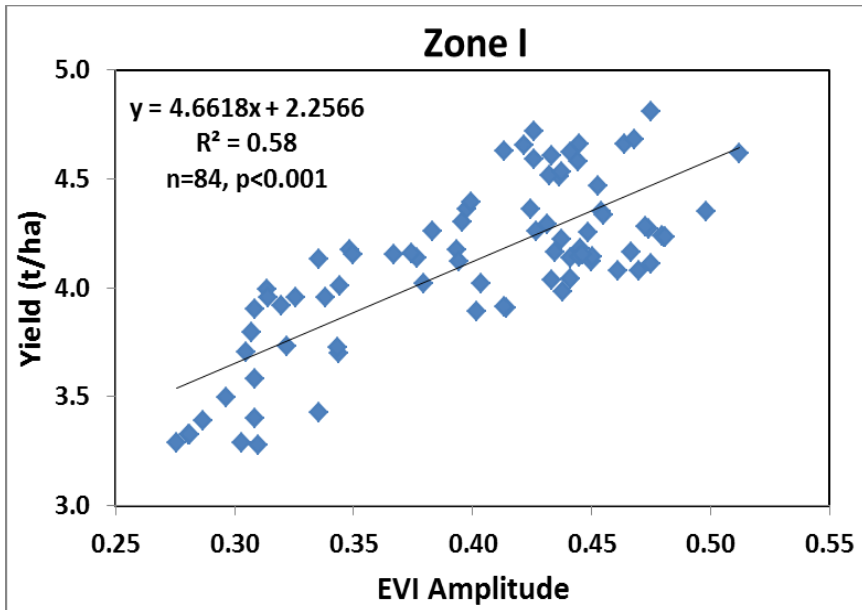


Punjab & Haryana Agro-ecoregions





The Models and their Performance



Agro-ecological Sub region of Punjab & Haryana	Regression model developed from 2000-01 to 2009-10 yield data		Validation (with 2010-11 yield data)	
	R ²	No. of observations	RMSE (kg/ha)	Error as percentage of Zone (%)
Zone I	0.58	84	500	10.4
Zone II	0.75	116	510	11.0
Zone III	0.78	110	420	9.4



The Forecasts



	Forecast for 2013-2014		Change over previous year		Estimates by State Dept		
	Production (M t)	Yield (t/ha)	Production (%)	Yield (%)	Production (M t)	Yield (t/ha)	Error Yield (%)
Punjab	16.97	4.84	+ 2.2	+ 2.3	17.62	5.01	-3.4
Haryana	11.48	4.59	+ 3.0	+ 2.9	11.80	4.72	-2.75

First Forecast

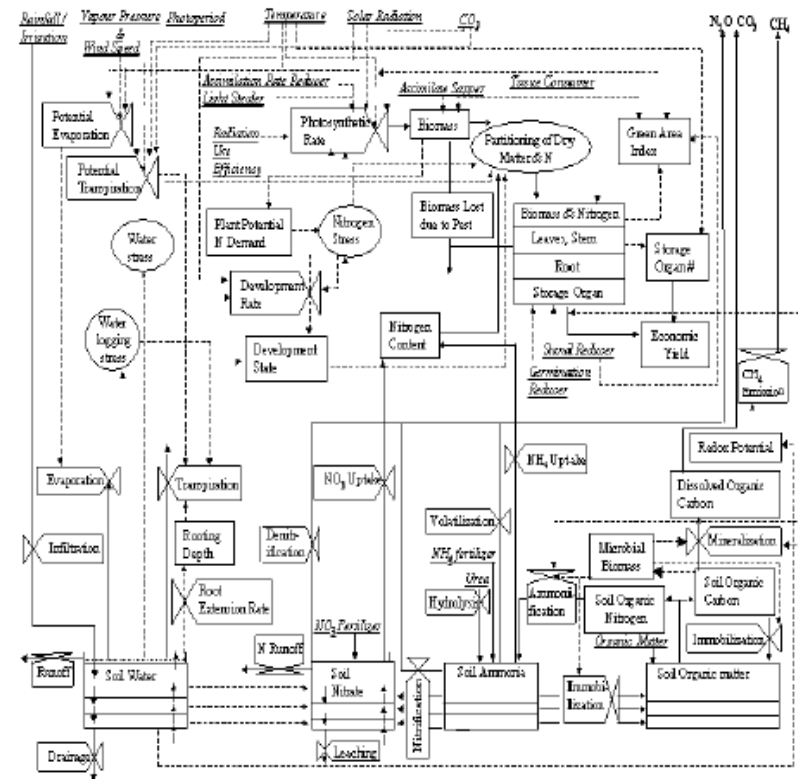
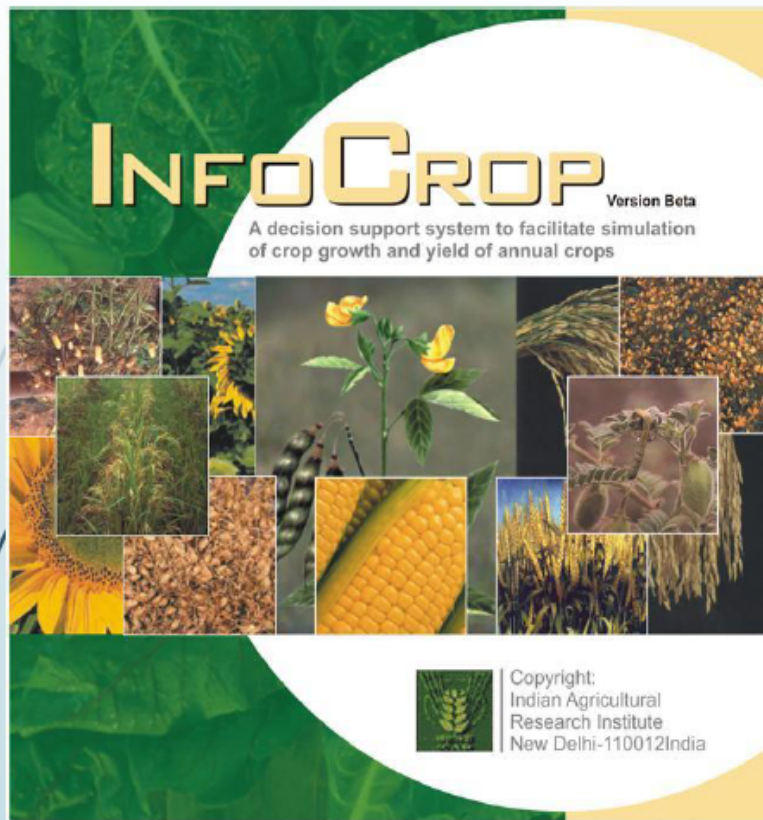
Used Satellite Data upto 20 March 2014.



Crop Simulation Model : InfoCrop



InfoCrop: A User-friendly Crop Modelling System



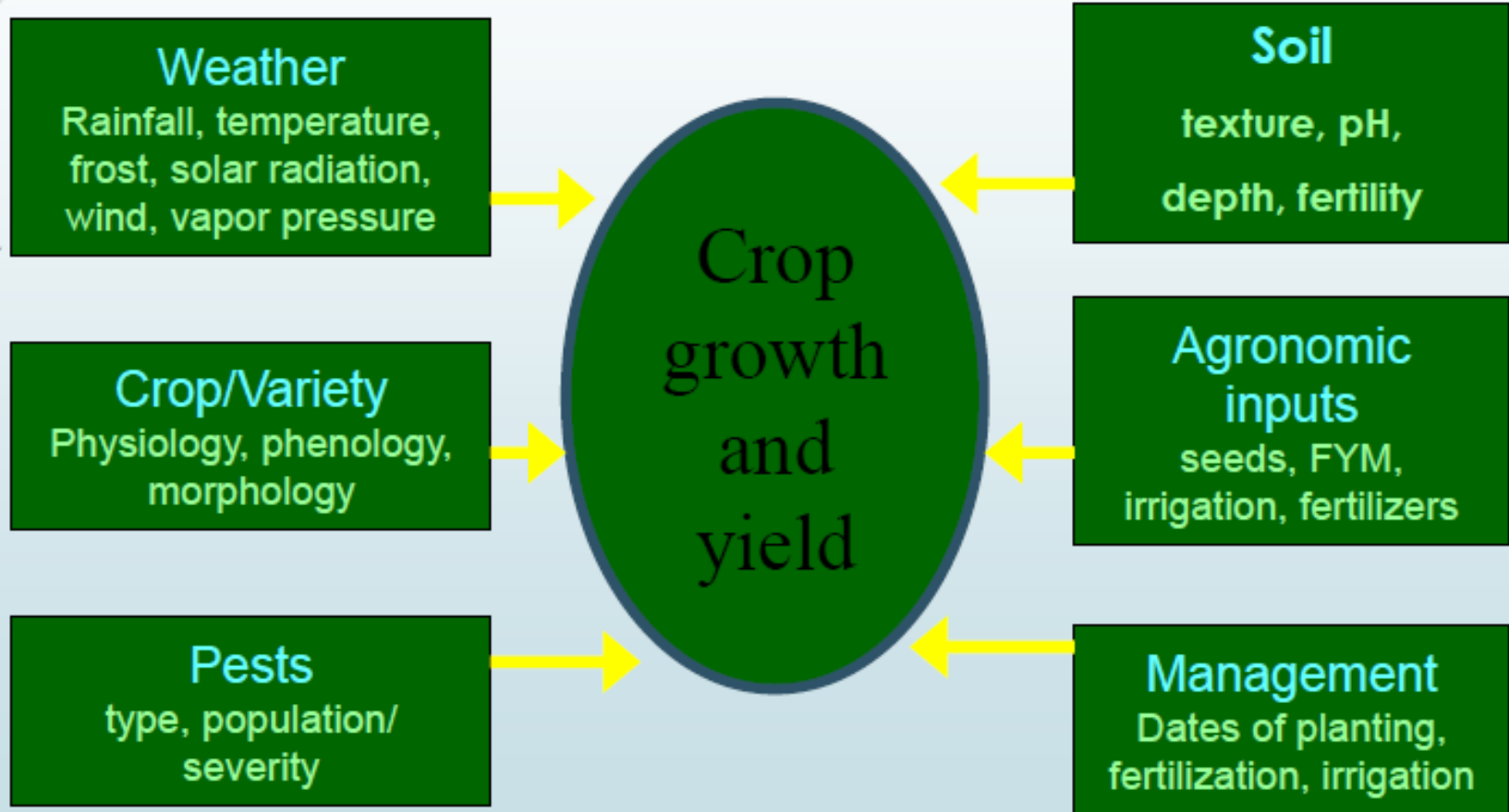
InfoCrop: Relational diagram



Crop Simulation Model : InfoCrop



InfoCrop: Simulates the Effect of Major Yield Regulating Factors



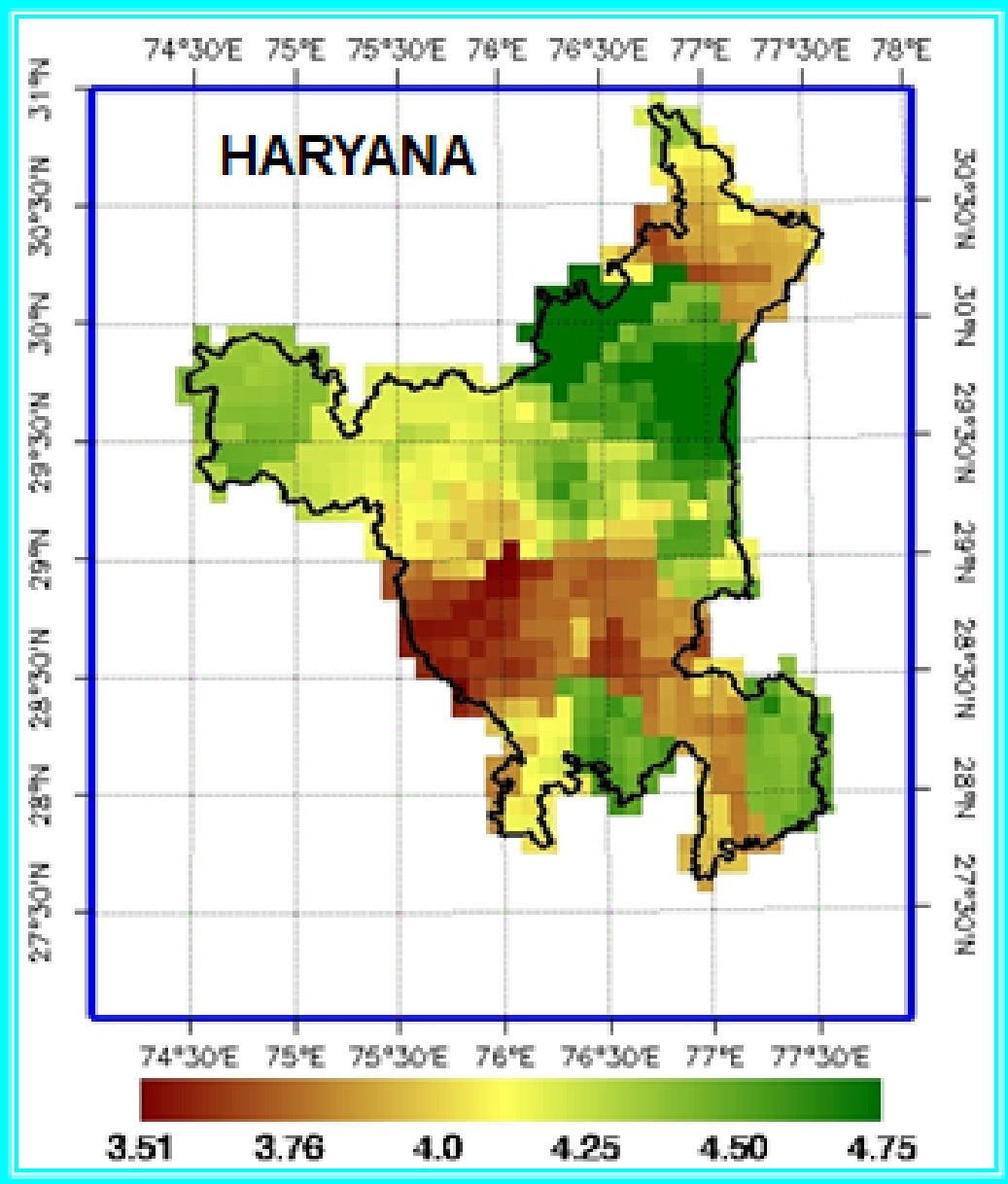


SCHEMATIC DIAGRAM OF CGMS



----- [INPUTS] -----

- STUDY AREA BOUNDS, GRID SIZE
- ADMINISTRATIVE BOUNDARY MAP
- RS DATA CLASSIFIED
- DAILY WEATHER DATA (POINTS)
- WEATHER CONSTANT
- SOIL MAP (NBSS&LUP)
- SOIL OC% (POINTS)
- DISTRICT-WISE CROP MANAGEMENT
Cultivar, Sowing Date, Irrigation, Fertilizer



[SIMULATION MODEL]

CROP SIMULATION MODEL (WTGROWS)

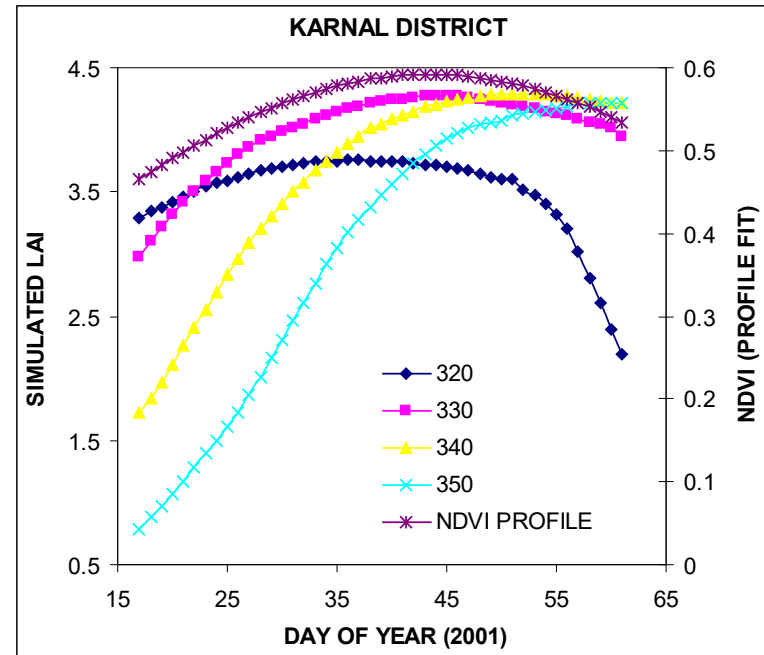
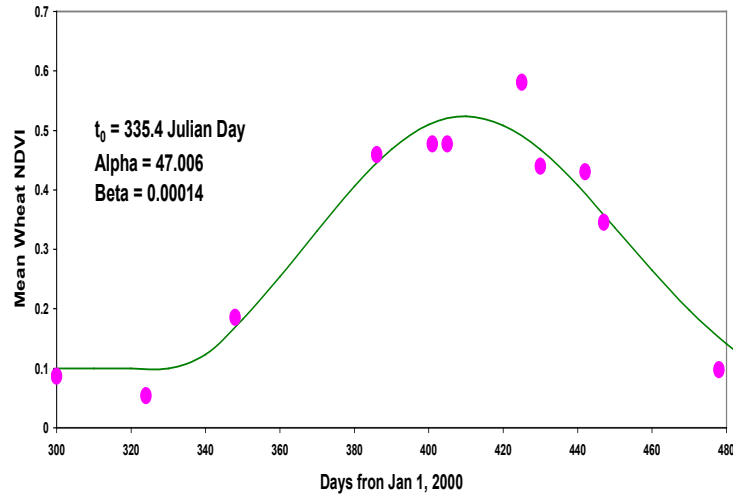
MODEL OUTPUT

DISTRICT-WISE AGGREGATED CROP YIELD

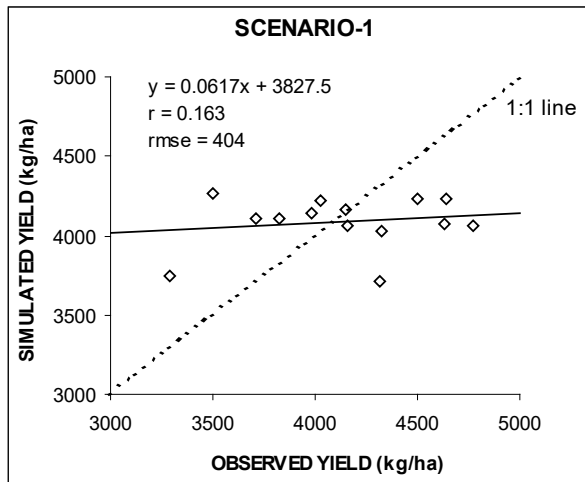
PTF – Pedo Transfer Function
.....> Selection by SHE

DEMONSTRATING RS-CGMS LINKAGE FOR PHENOLOGY

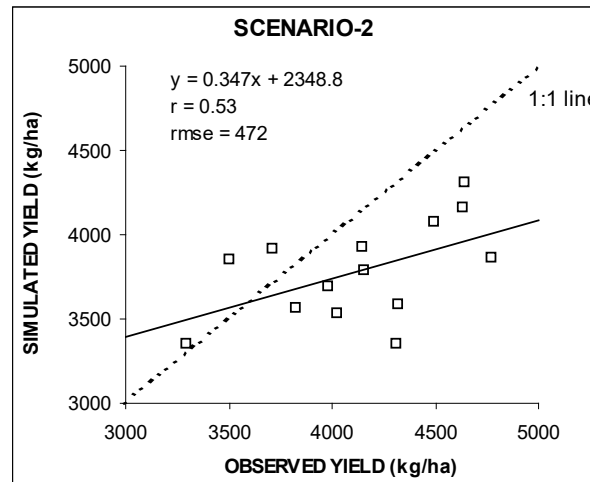
WiFS Profile



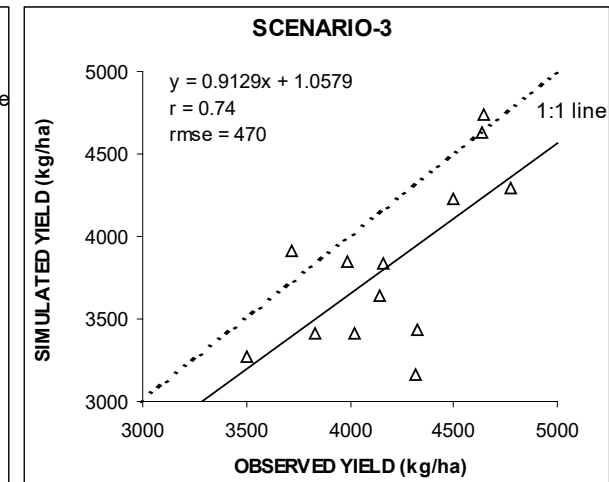
Fixed Inputs (DOS, I, N)



Variable Inputs (I, N)



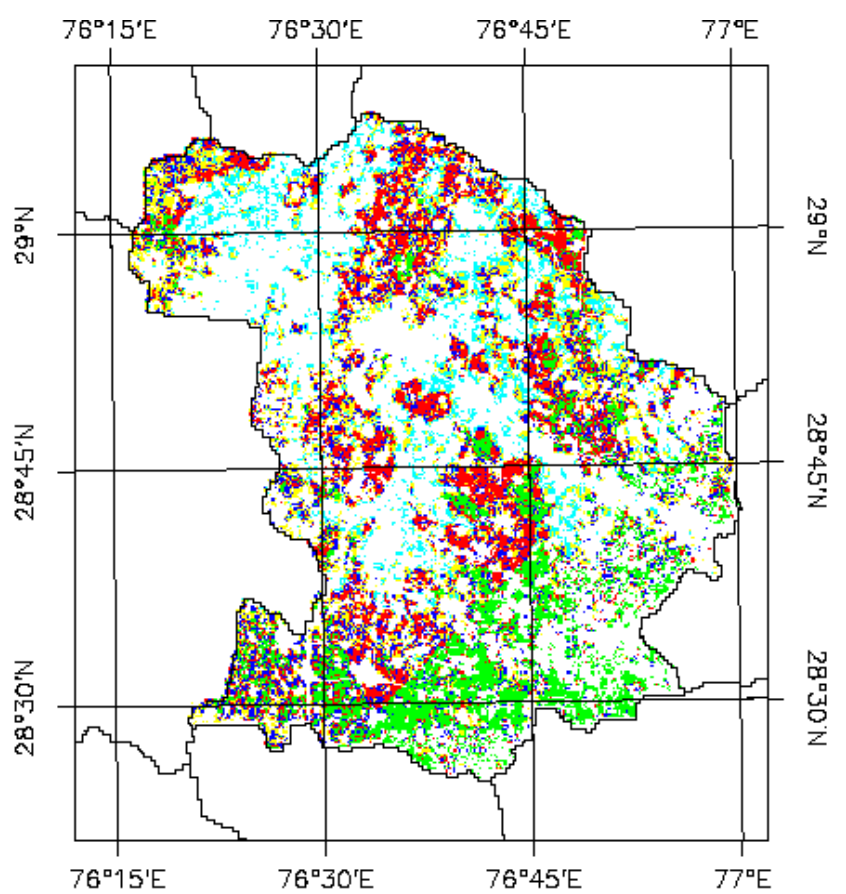
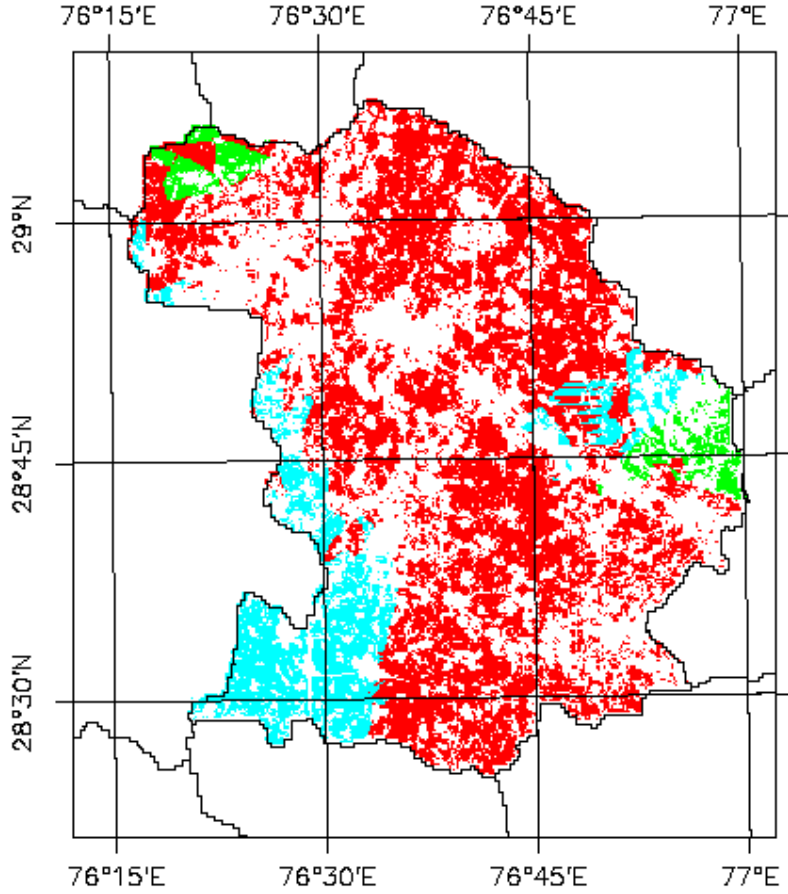
DOS from RS





Without Assimilation

With Assimilation

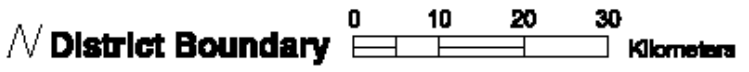
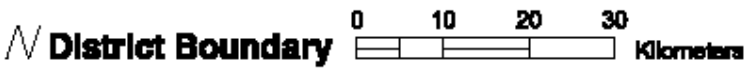


GRAIN YIELD (t/ha)

- 4.03 - 4.25
- 4.25 - 4.50
- 4.50 - 4.76

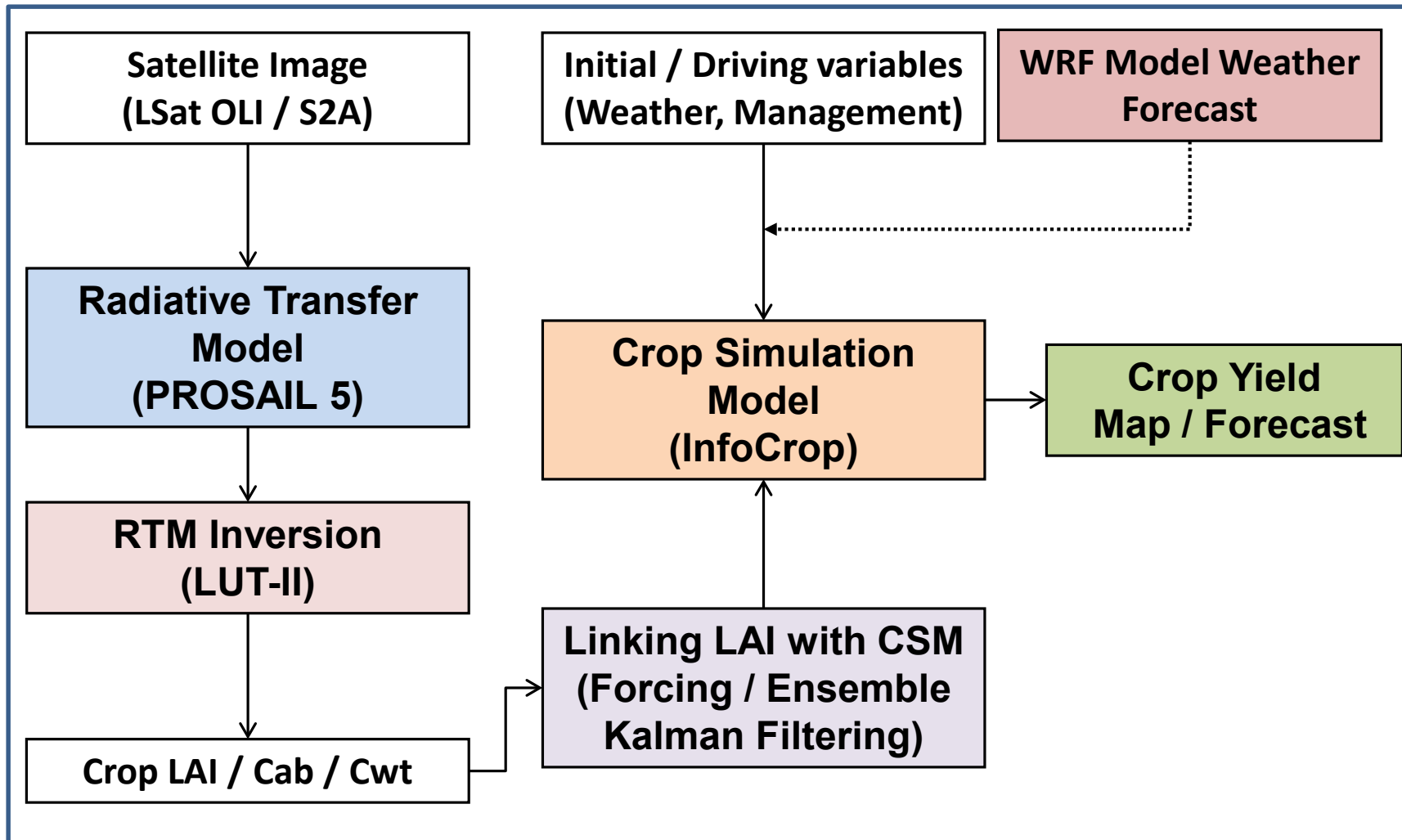
GRAIN YIELD (t/ha)

- 2.5 - 4.0
- 4.0 - 5.0
- 5.0 - 5.5
- 5.5 - 5.75
- 5.75 - 6.1

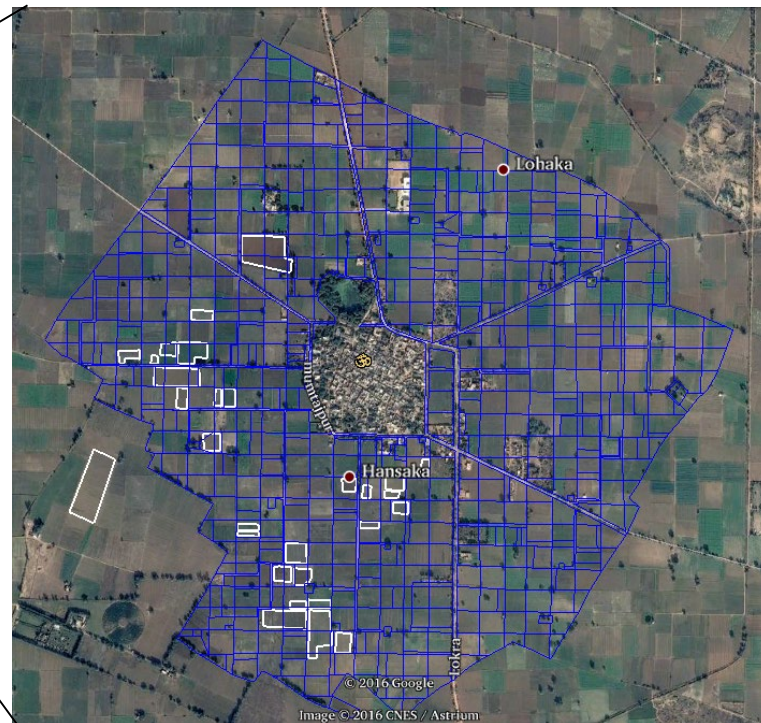
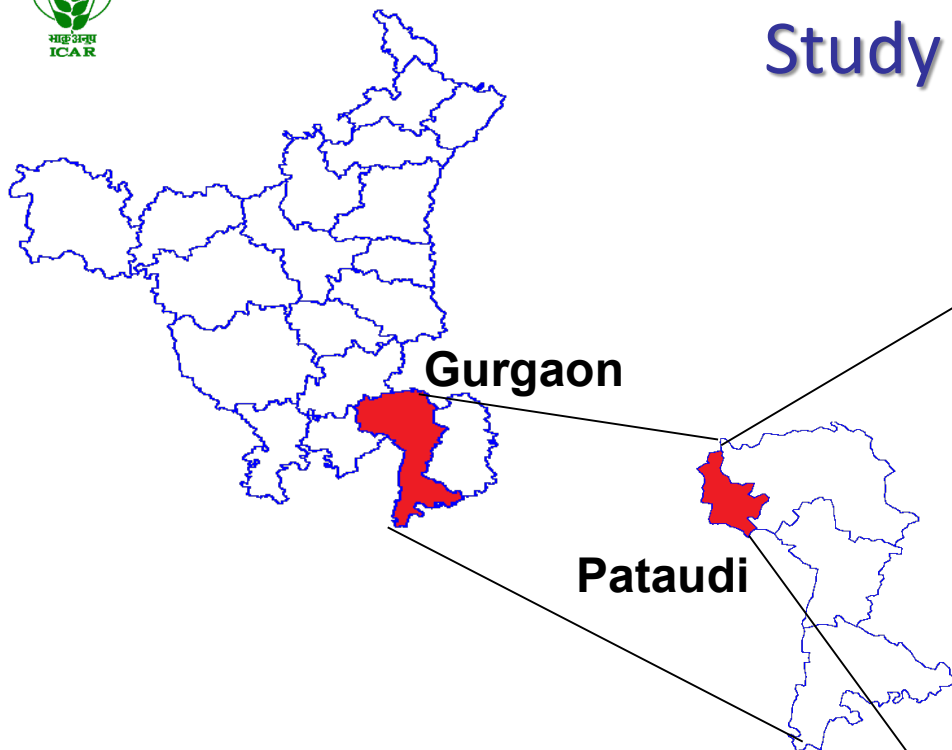




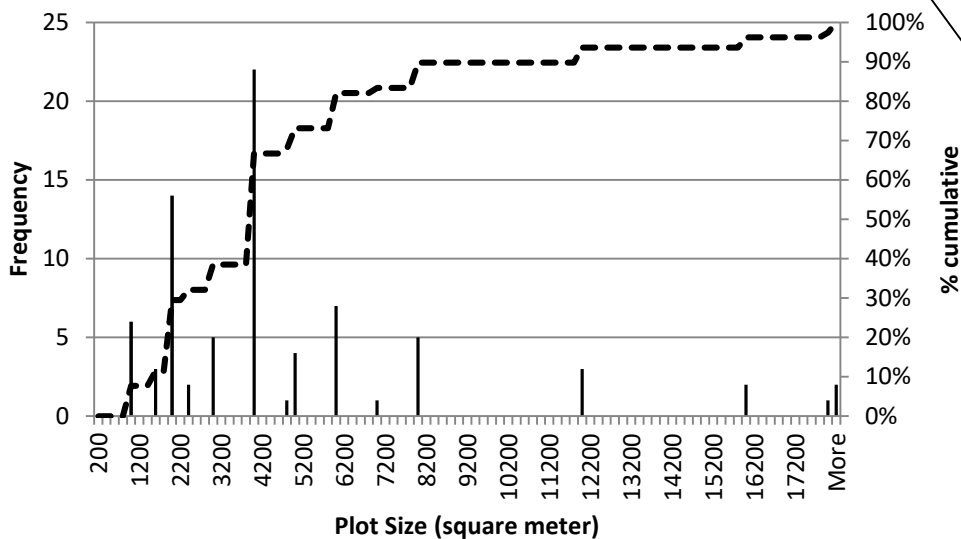
Wheat Crop Yield Modelling : RS Assimilation



Study area

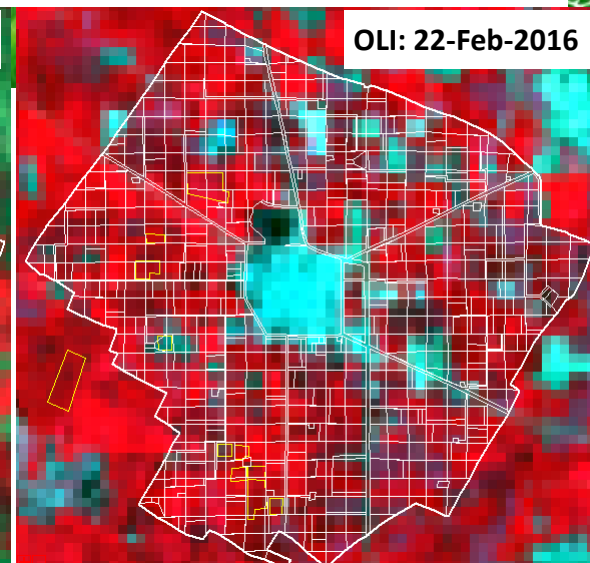
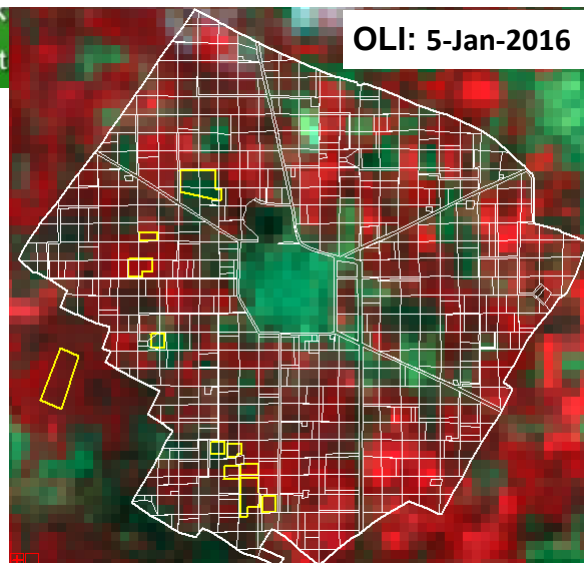
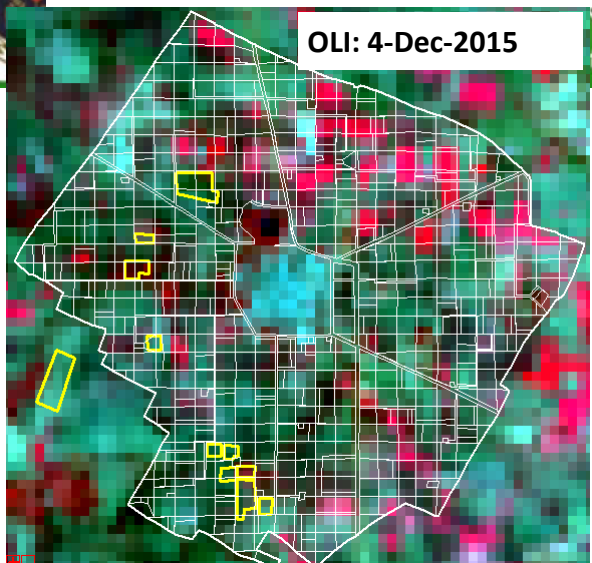


Mumtazpur & Lokra

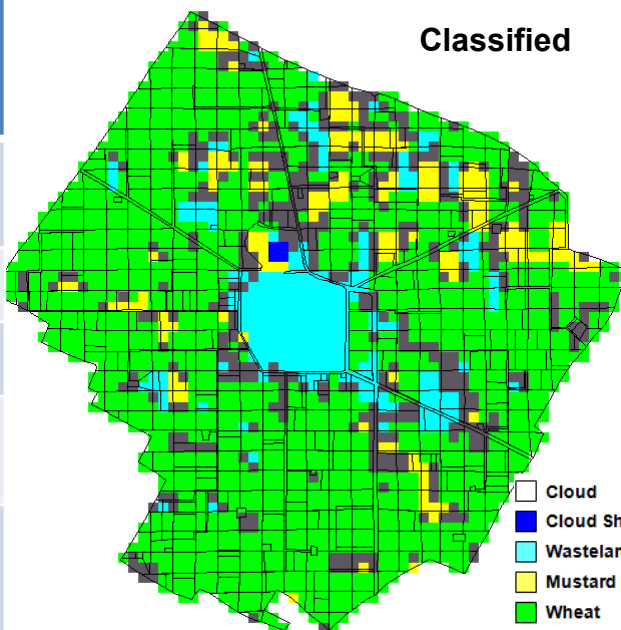


█ Frequency - - - % cumulative

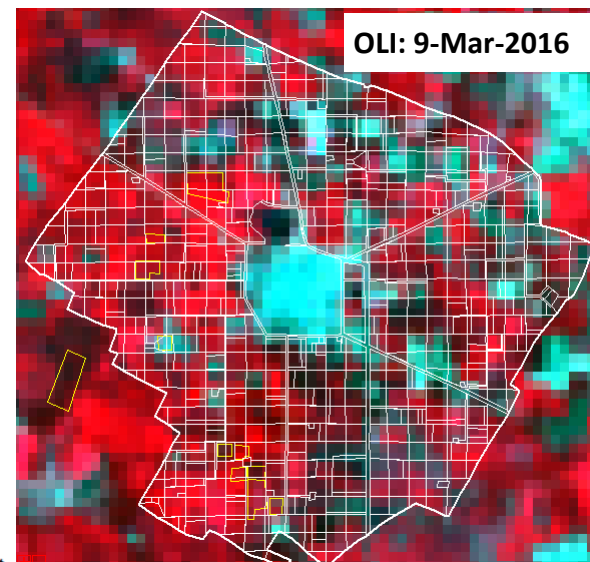
LandSat OLI Time-series Images of Mumtazpur Village



Category	Area (ha)	% of Total
Non-Agril	21.0	09.85
Mustard	15.0	07.14
Wheat	141.0	67.08
Other Veg	34.0	17.03
Village Area	211.0	100.00



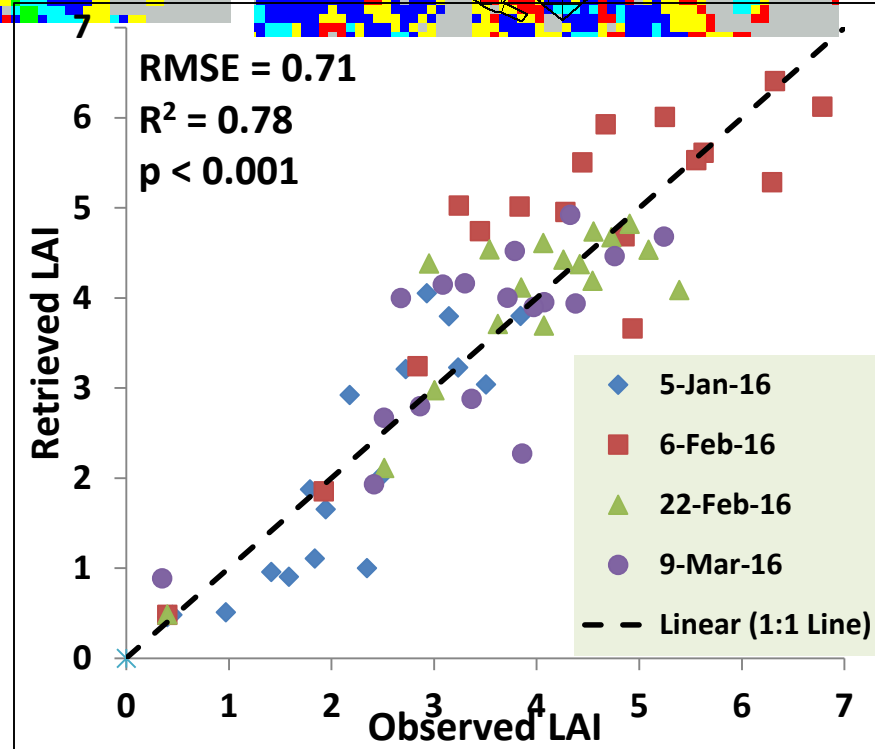
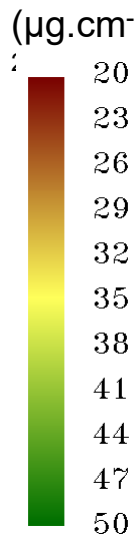
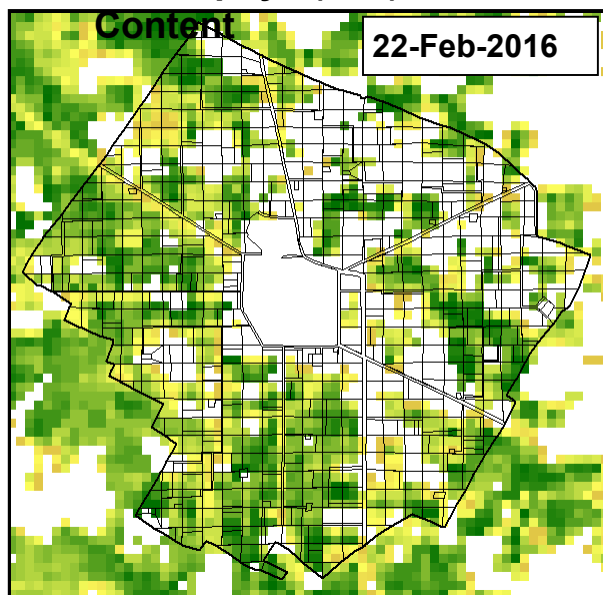
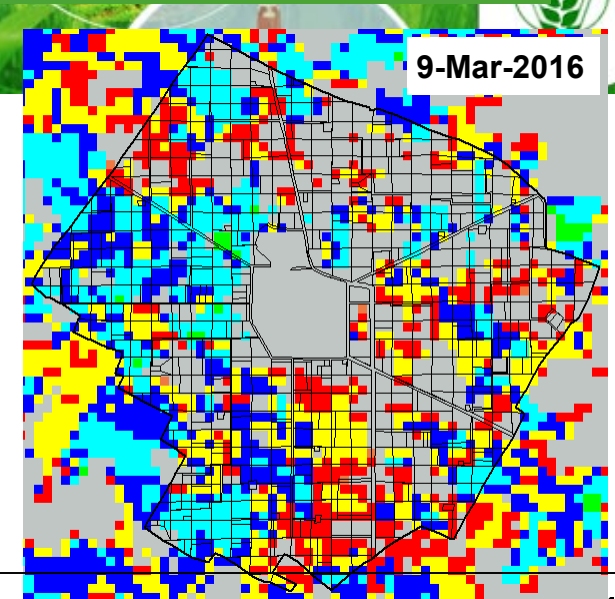
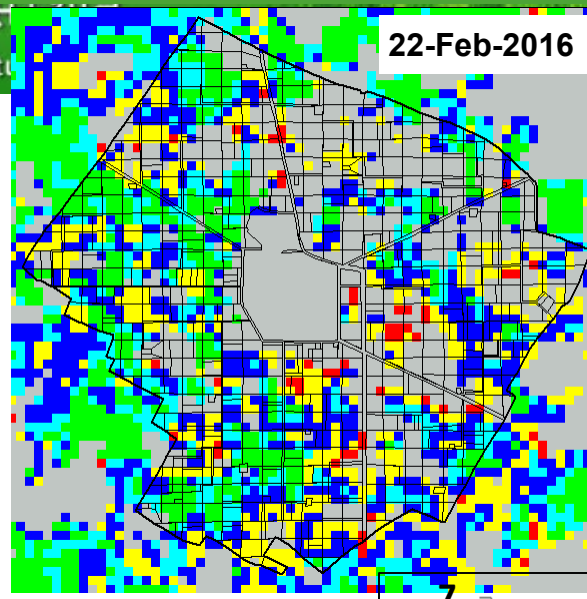
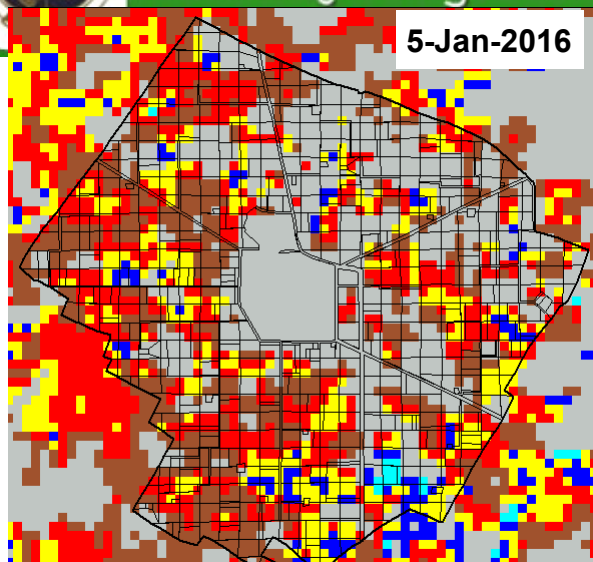
- Cloud
- Cloud Shadow / Water
- Wasteland / Settlement
- Mustard
- Wheat
- Other



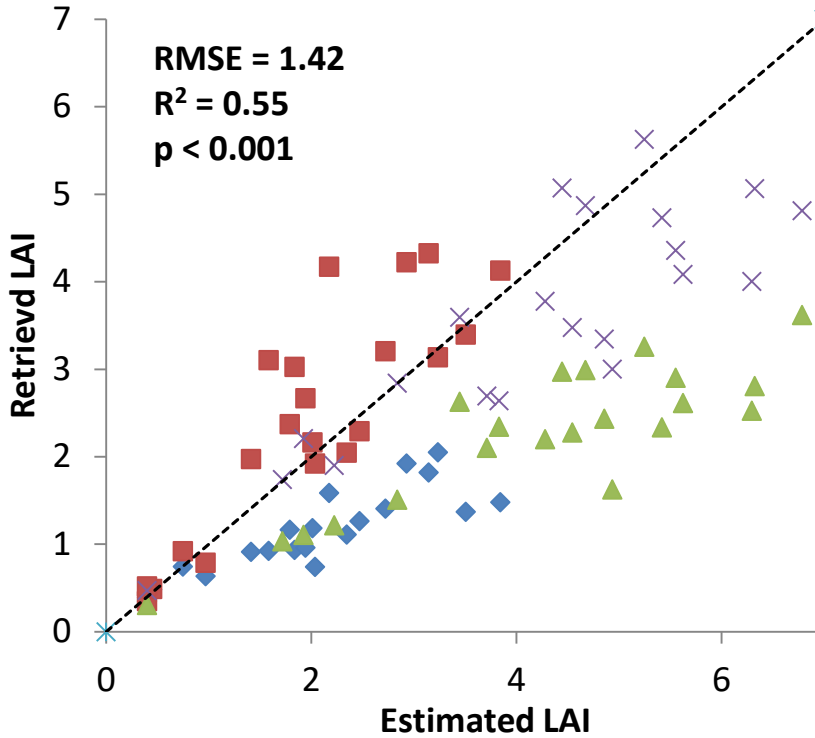
MODEL INVERSION RESULTS



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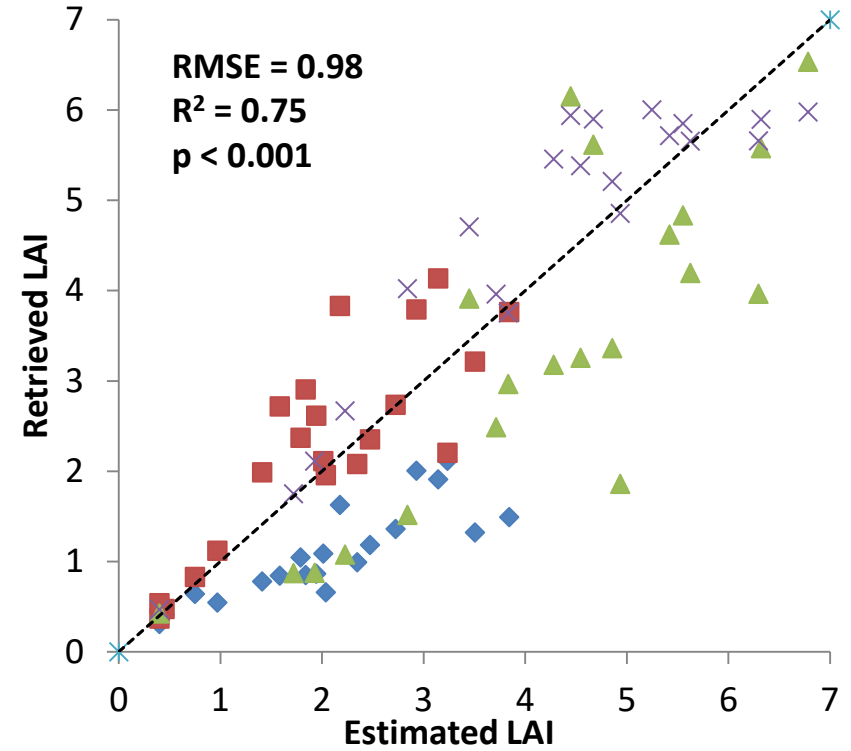


LibRadtran



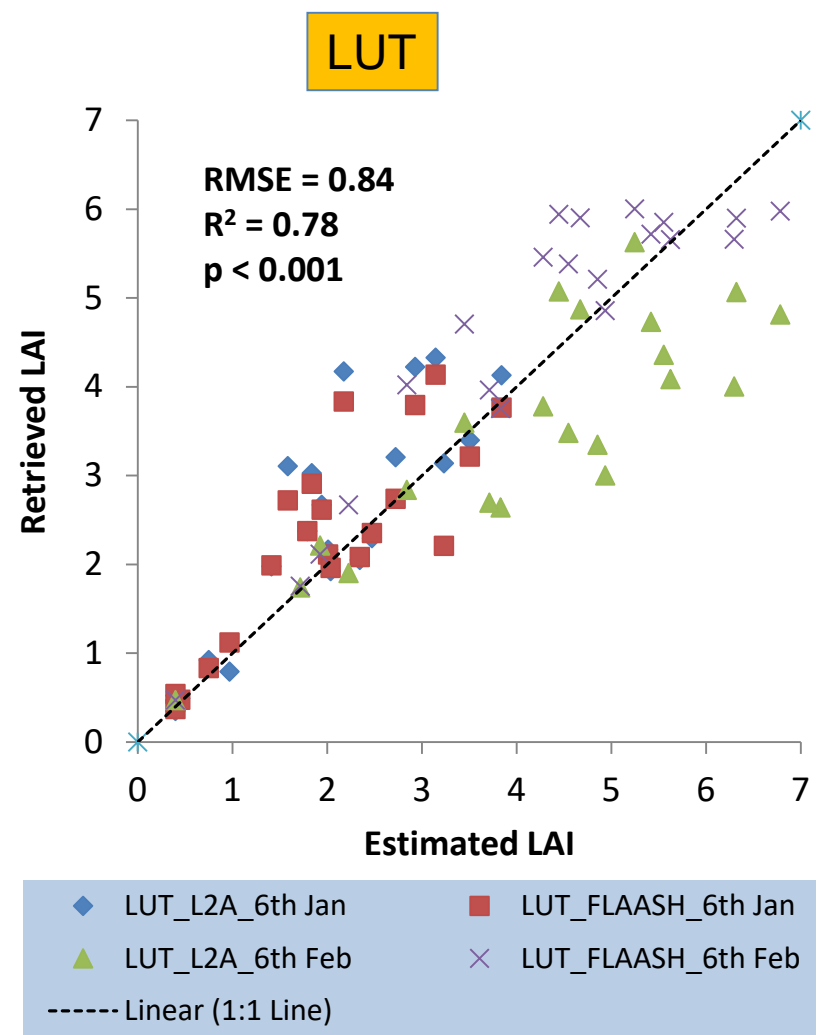
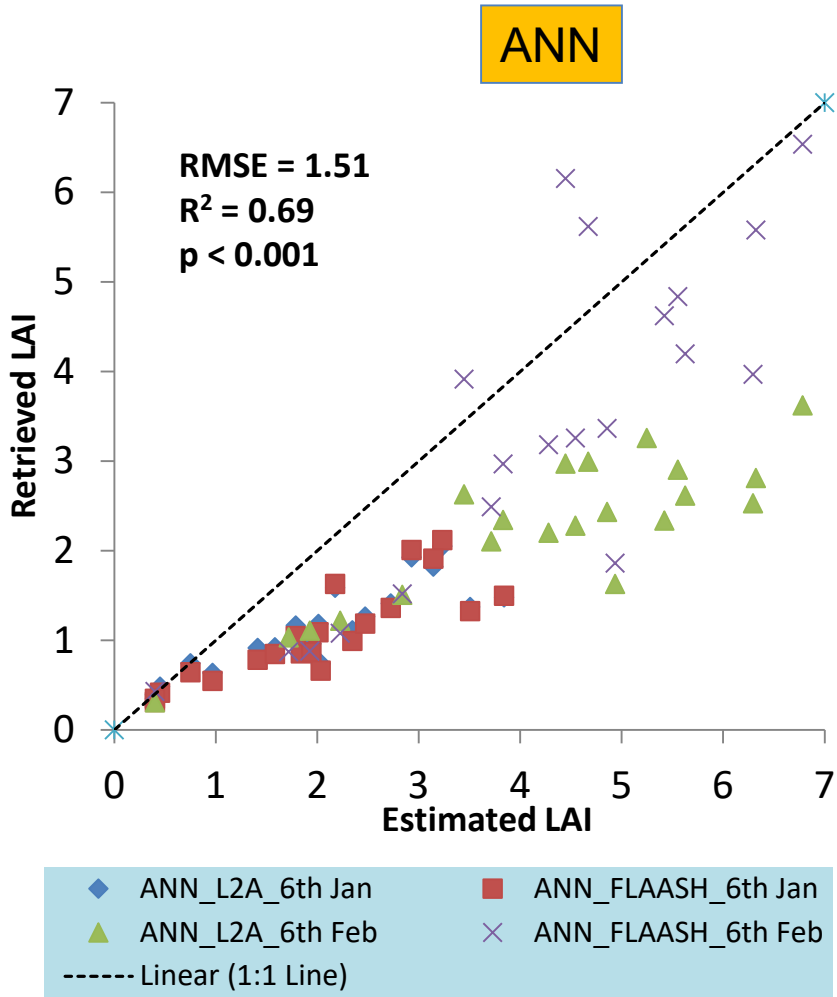
◆ L2A_ANN_6th Jan ■ L2A_LUT_6th Jan
▲ L2A_ANN_6th Feb ✕ L2A_LUT_6th Feb
----- Linear (1:1 Line)

MODTRAN



◆ FLAASH_ANN_6th Jan ■ FLAASH_LUT_6th Jan
▲ FLAASH_ANN_6th Feb ✕ FLAASH_LUT_6th Feb
----- Linear (1:1 Line)

Comparison of inversion approach (ANN & LUT) for Sentinel-2



Student t-test statistics to compare the effect of spatial and spectral resolutions on LAI retrieval.

Spectral bands	OLI_6bands	S2A_6 bands	S2A_6bands + VNIR	S2A_6bands + rededge1_2	S2A_6bands+VNIR+rededge1_2
OLI_6bands		0.24			
S2A_6 bands			-0.21	2.0373**	2.2007**
S2A_6bands + VNIR				2.1063**	2.2588**
S2A_6bands + rededge_1_2					0.22
S2A_6bands+VNIR+rededge1_2					

(**significant at $p < 0.05$)



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Exp No.	Season	Initial Soil moisture	Soil parameters	Irrigation	Fertilizer	Date of sowing	LAI assimilation	Phenology adjustment
1	2015-16	Fixed	Fixed	Fixed	Fixed	Measured	FORCING	No
2	2016-17	Fixed	Fixed	Fixed	Fixed	Measured	FORCING	No
3	2015-16	Fixed	Fixed	Fixed	Fixed	Measured	ENKF	No
4	2016-17	Fixed	Fixed	Fixed	Fixed	Measured	ENKF	No
5	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	FORCING	No
6	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	FORCING	No
7	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	ENKF	No
8	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	ENKF	No
9	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	FORCING	Yes
10	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	FORCING	Yes
11	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	ENKF	Yes
12	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	ENKF	Yes
13	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	No	Yes
14	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	No	Yes
15	2015-16	Fixed	Fixed	Fixed	Fixed	Fixed	No	No
16	2016-17	Fixed	Fixed	Fixed	Fixed	Fixed	No	No
17	2015-16	Fixed	Fixed	Fixed	Fixed	Measured	No	No
18	2016-17	Fixed	Fixed	Fixed	Fixed	Measured	No	No



Crop Yield Maps



LAI1

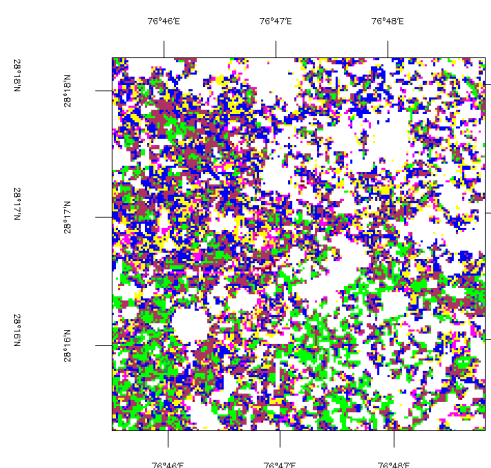
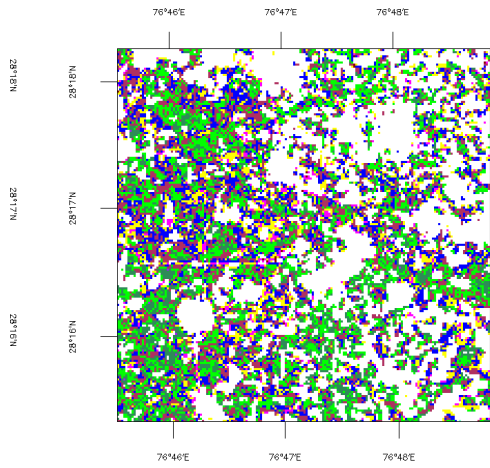
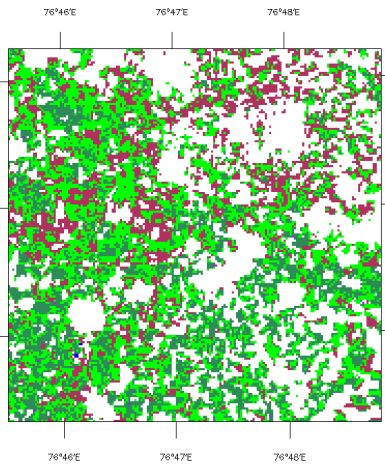
LAI2

LAI3

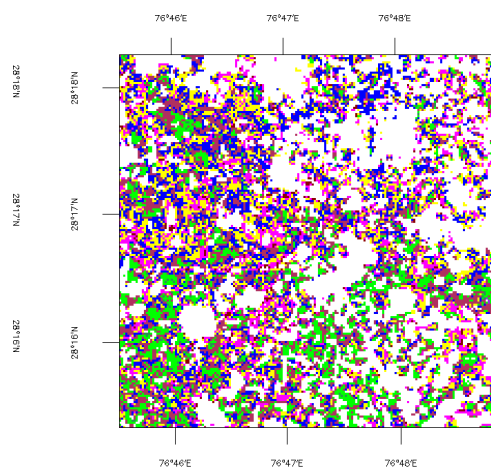
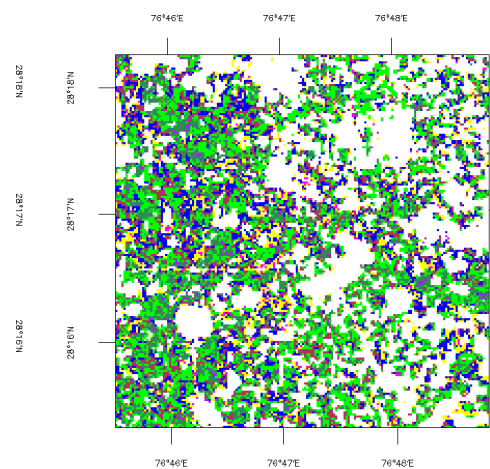
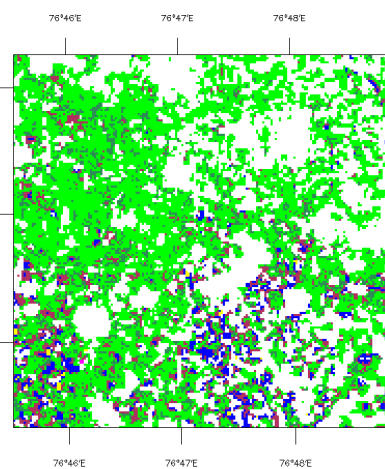
Grain Yield (Kg/ha)

- < 2.5
- 2.5 - 3.0
- 3.0 - 3.5
- 3.5 - 4.0
- 4.0 - 4.5
- 4.5 - 5.0
- 5.0 - 5.5
- 5.5 - 6.0
- 6.0 - 6.5
- 6.5 - 7.0
- > 7.0

LAI + AW assimilation



LAI + WF assimilation

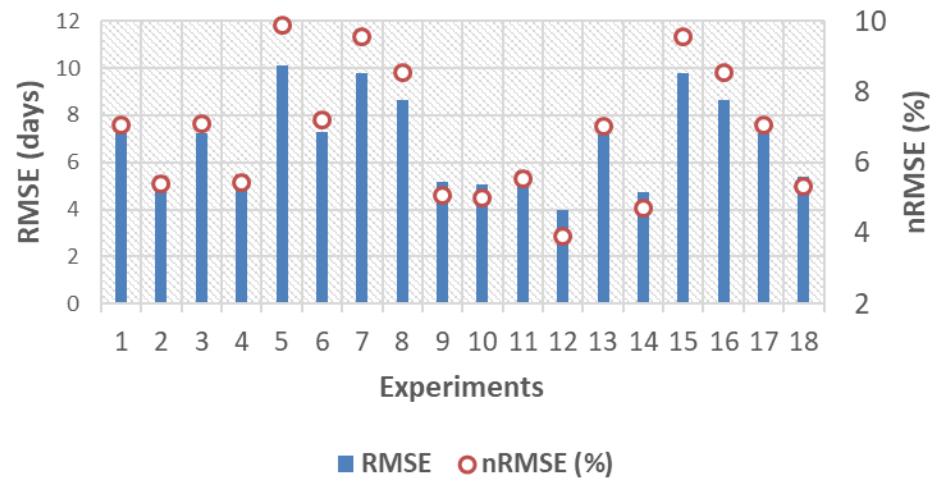




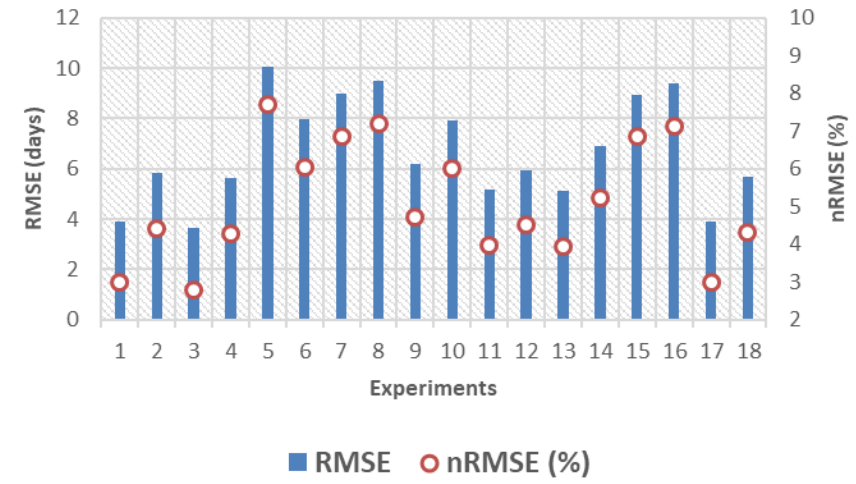
SIMULATION PERFORMANCE



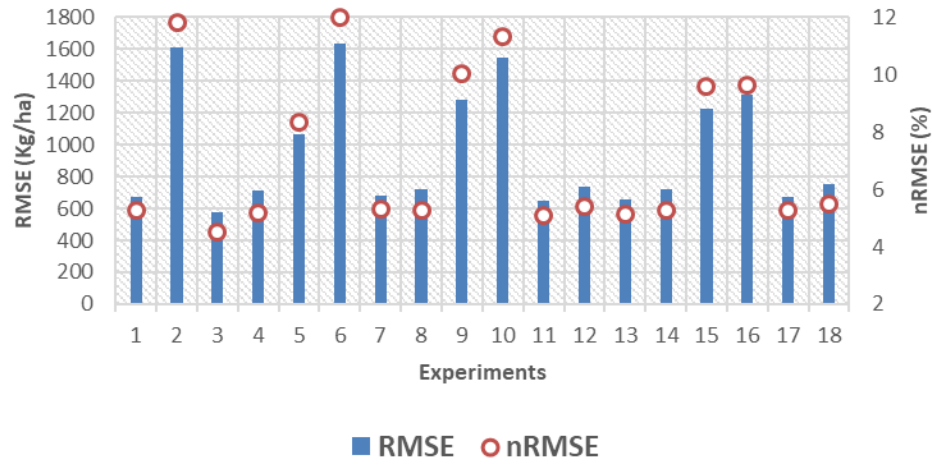
Days to anthesis



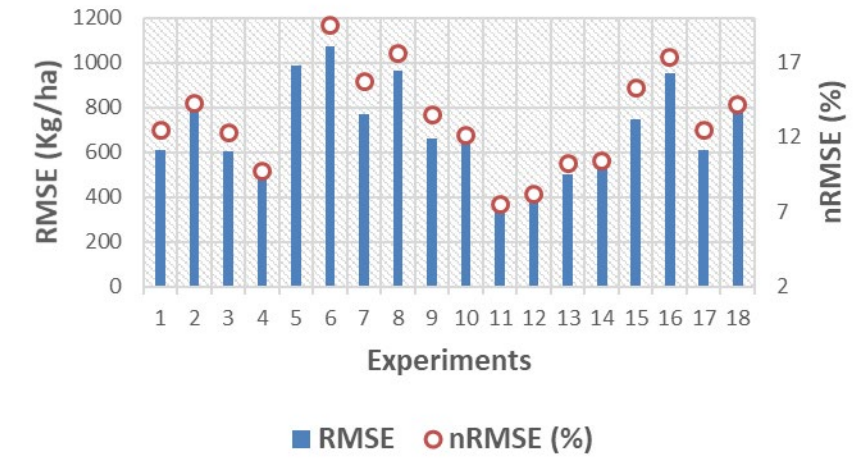
Days to physiological Maturity



Total dry matter (TDM)

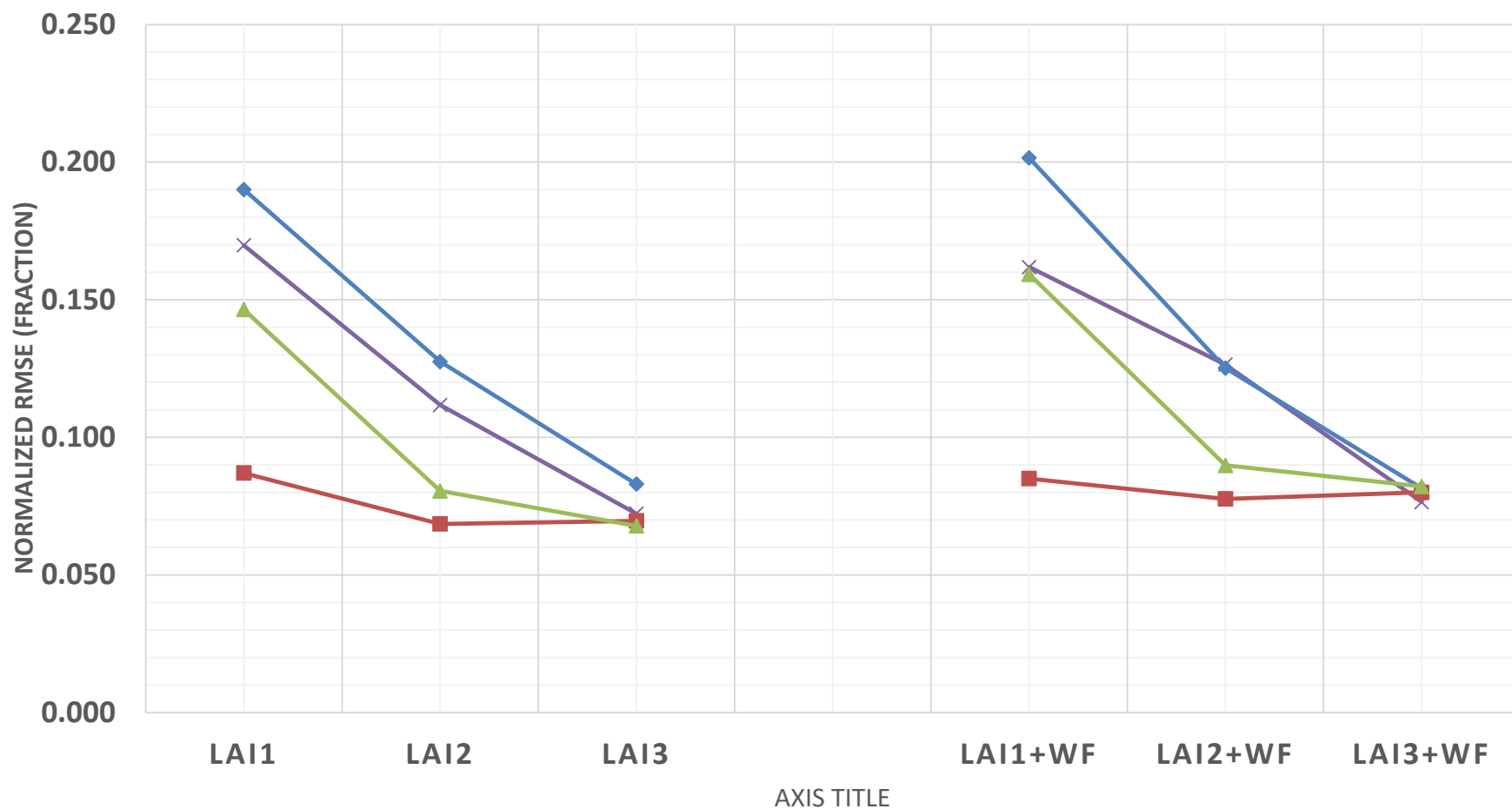


Grain Yield





Effect of progressive LAI assimilation on model outputs of phenology, TDM and yield



—x— Yield_2015-16 —◆— Yield_2016-17 —■— TDM_2015-16 —▲— TDM_2016-17



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Crop

Insurance



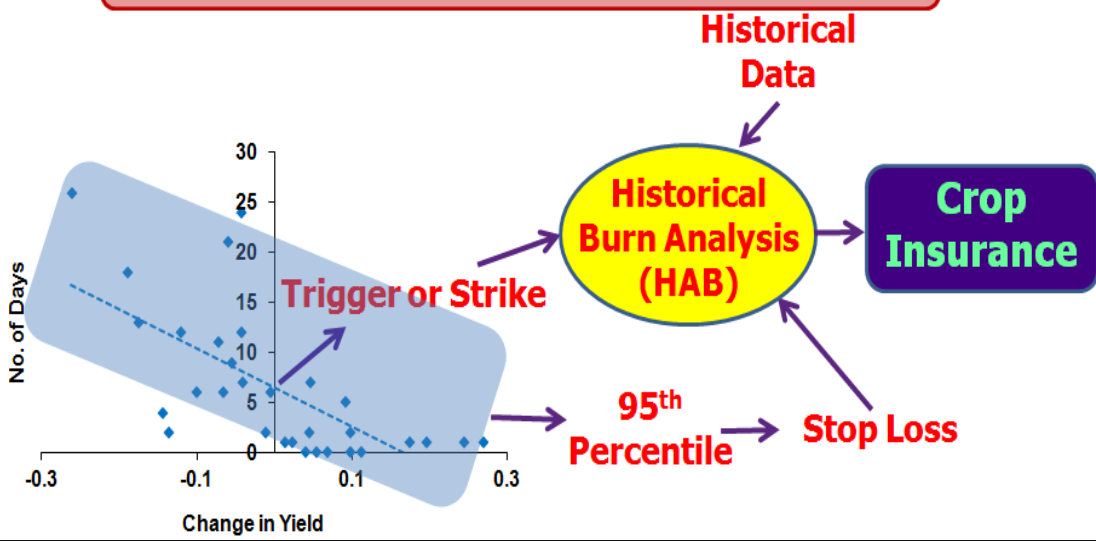
Crop Insurance



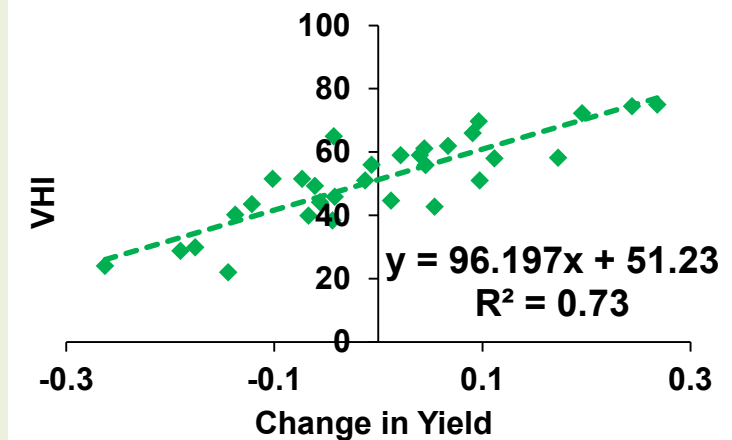
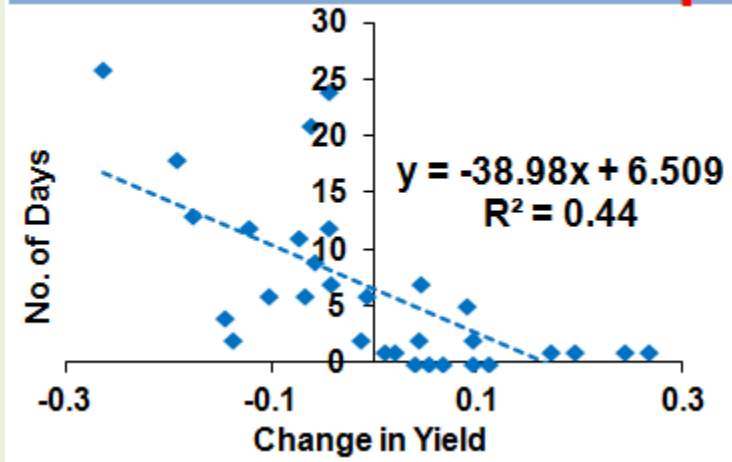
EO Data Applications:

- Efficient CCE sampling plan
- Improved weather index insurance
- RS based Index Insurance Product
- Crop loss for indemnity

Historical Burn Analysis



Extreme Maximum Temp



Wheat Crop Insurance:

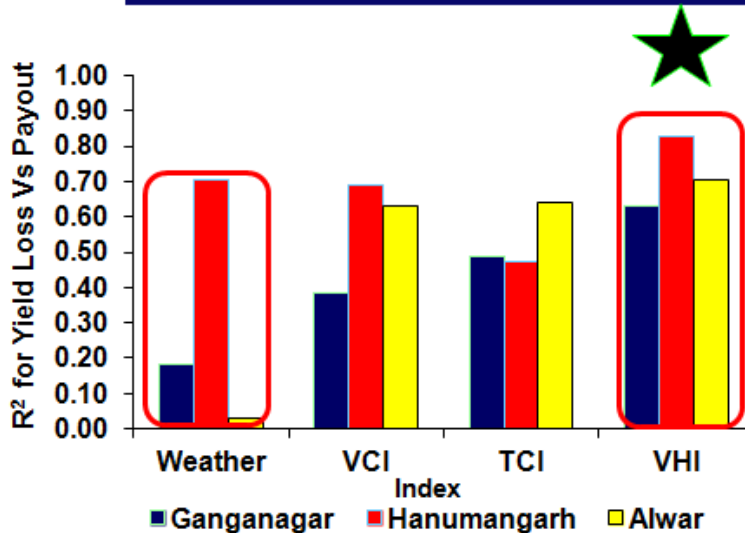
- Peril; high temperature stress during anthesis
- RS Parameters: Phenology, NDVI, LST
- Ganganagar district



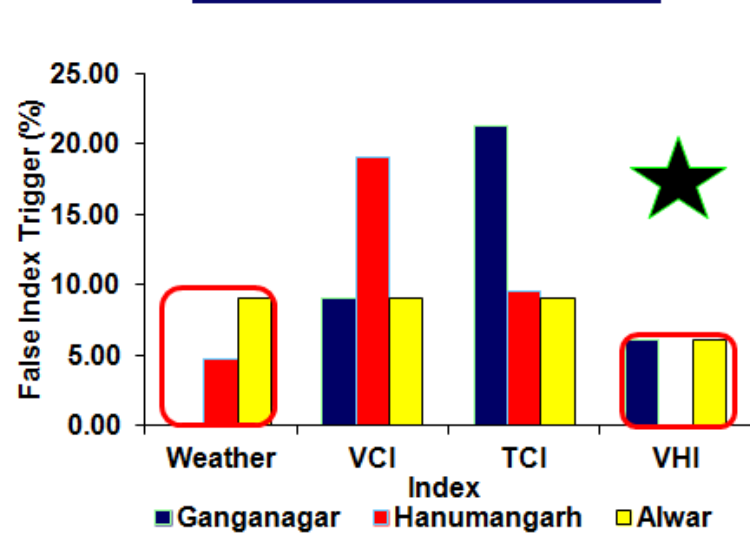
RS Based Index Insurance Product Evaluation



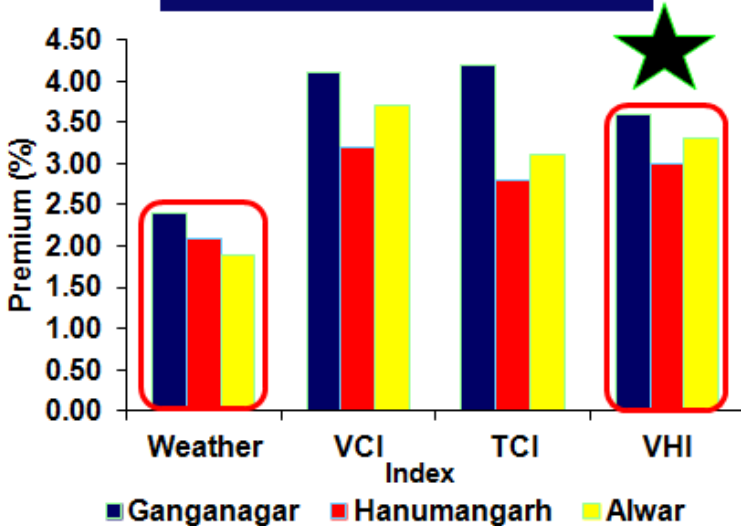
R² for Yield loss & Payout



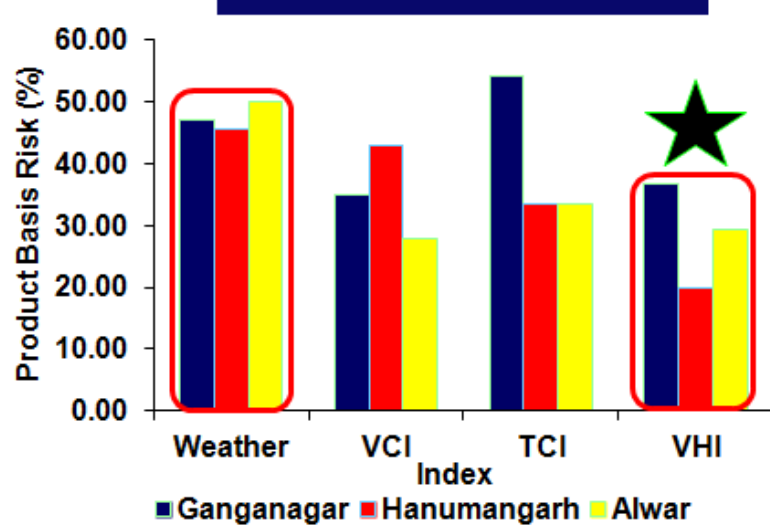
False Trigger



Premium



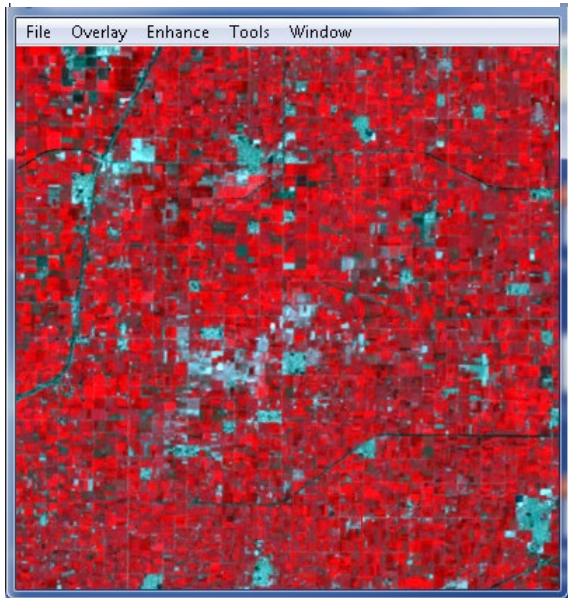
Basis Risk



Methodology of Yield Loss Modelling



LandSat ETM+ Image

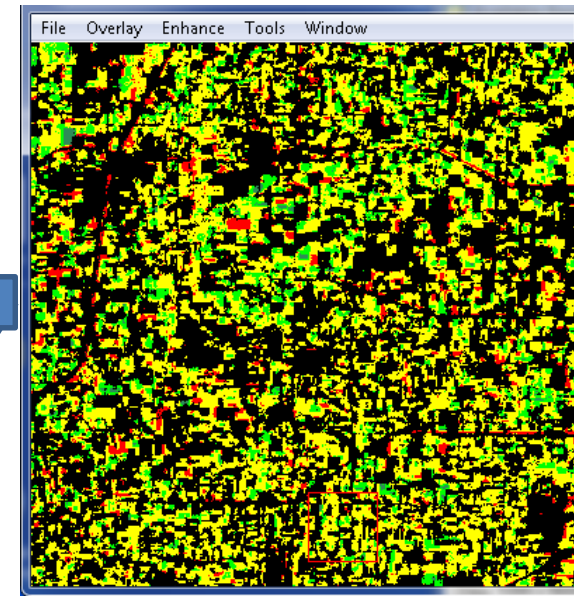


Pixels

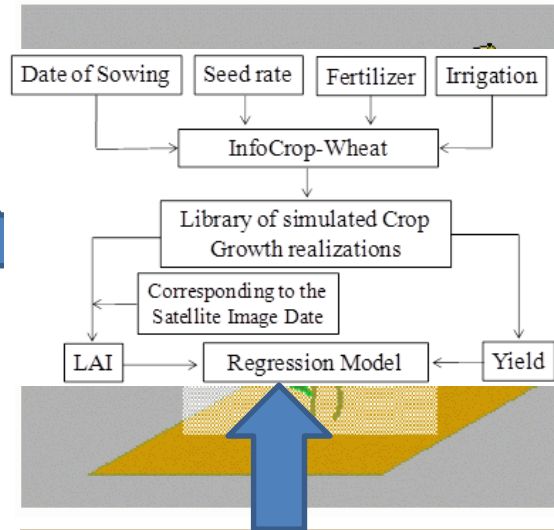
3232370 = 3.2 Million

Sri Ganganagar District

Leaf Area Index Image



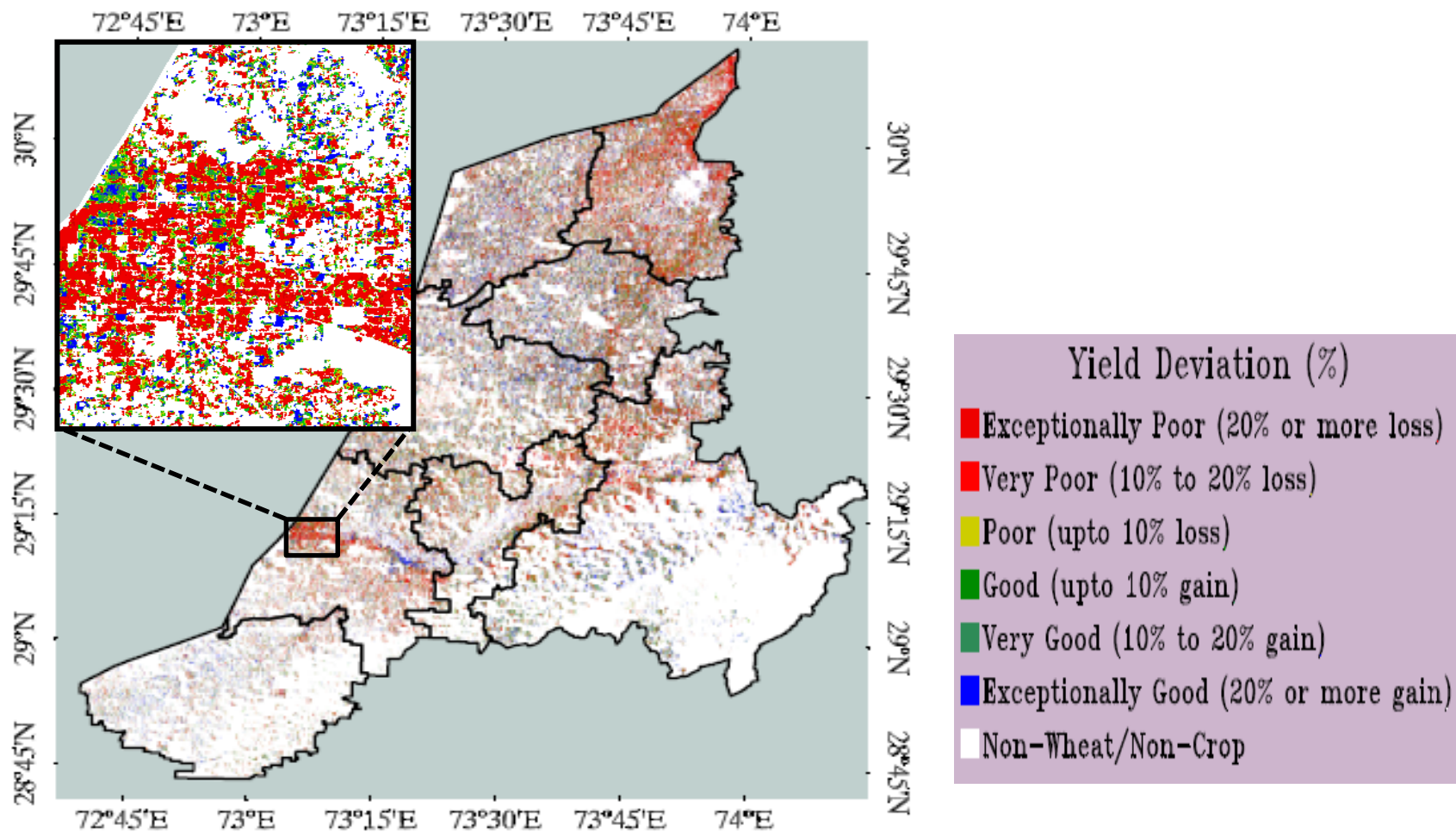
PROSAIL Model



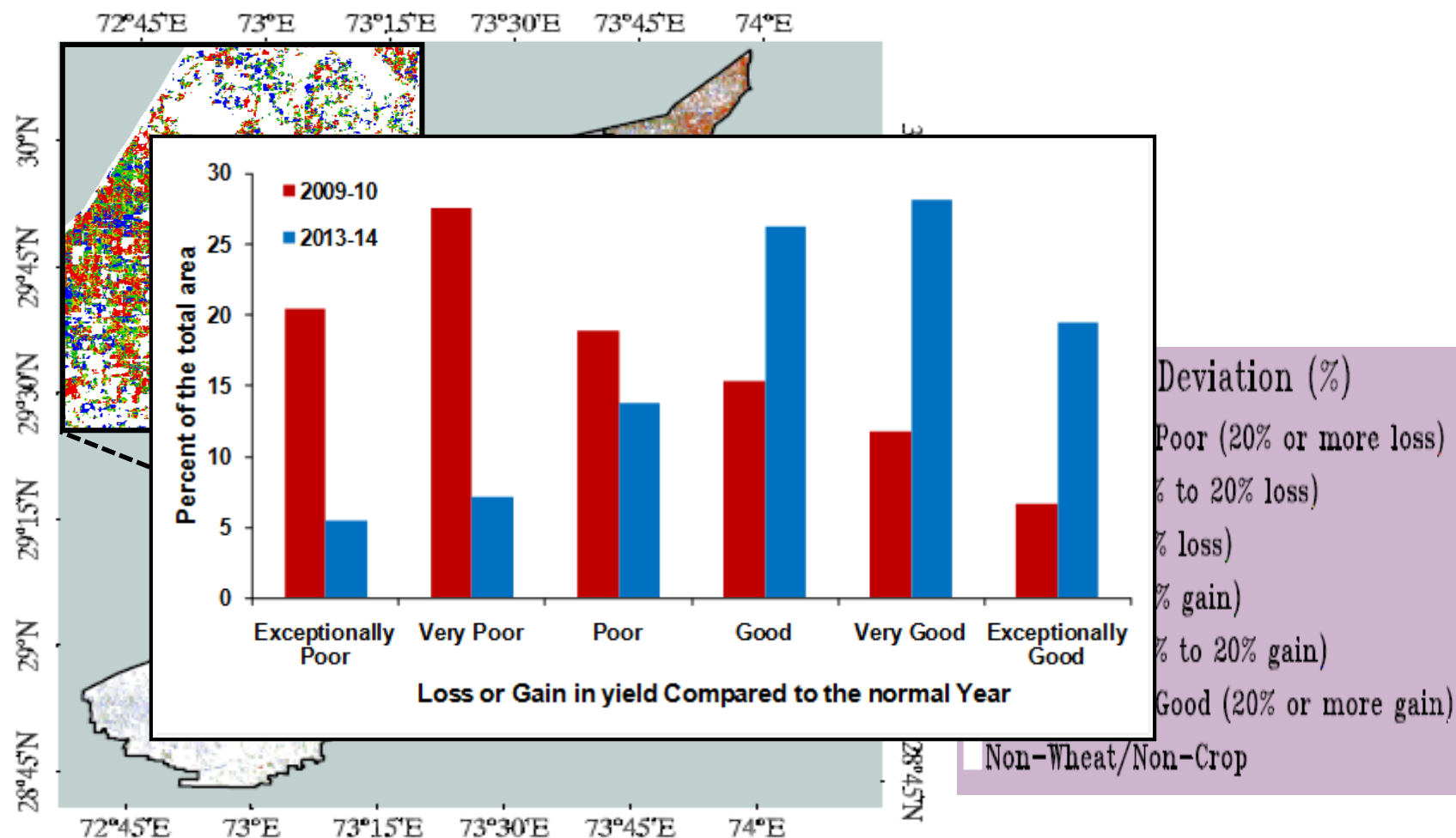
Crop Status	Crop Year	Yield (t/ha) DES Data
Bad Year	2009-10	2.85
Normal Year	2012-13	3.86
Good Year	2013-14	4.17



Yield deviation map of Ganganagar district for the rabi season of 2009-10 w.r.t 2012-13

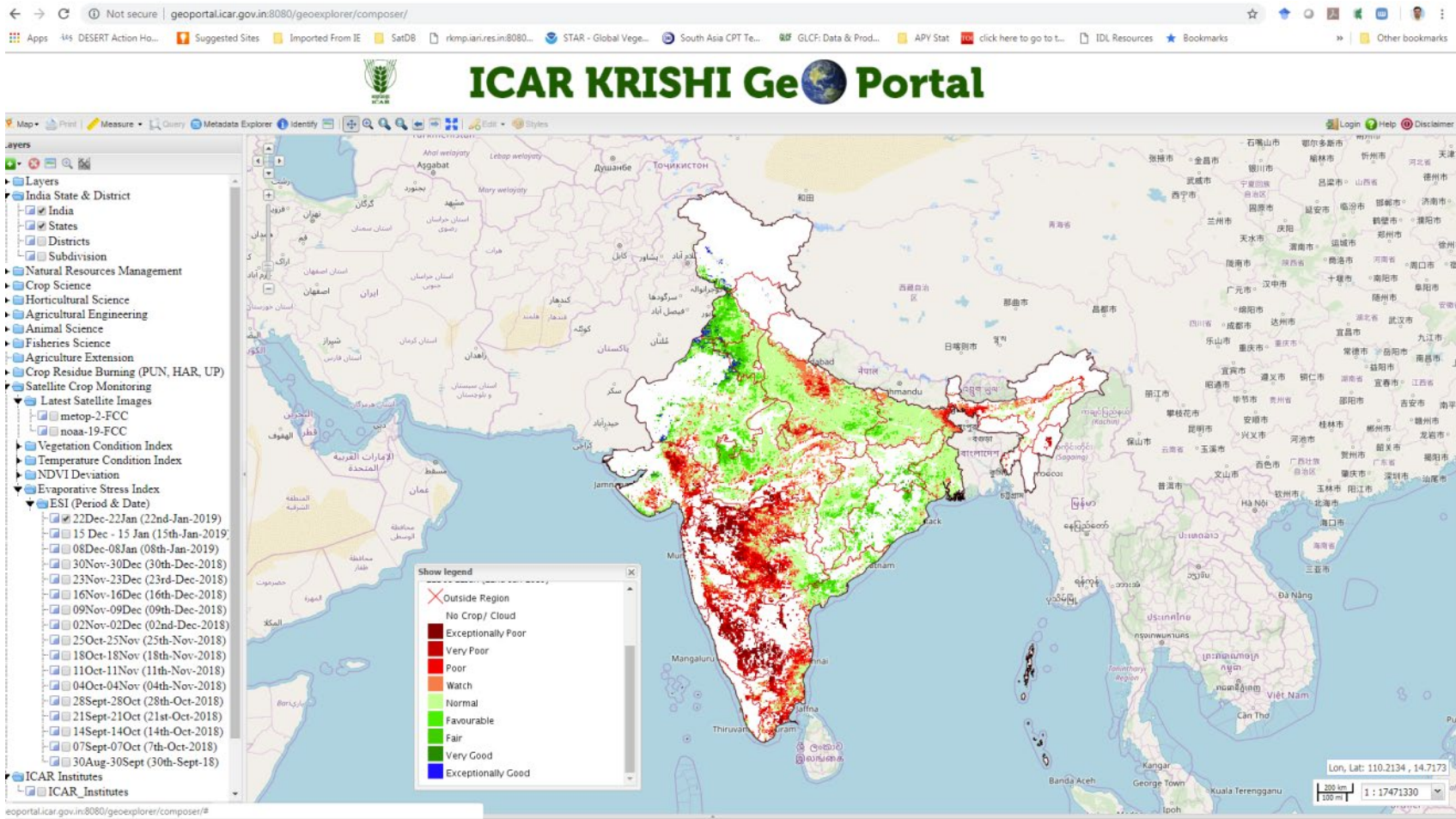


Yield deviation map of Ganganagar district for the rabi season of 2013-14 w.r.t 2012-13





Operational System : Geo-Portal





Way Forward



- Developing a operational system to implement LAI retrieval and assimilation into Crop simulation model and use of WRF weather forecast for wheat**
- Convergence of evidence in season from ground observations and other evidences**
 - Satellite weather based indices**
 - Crop condition indices**
 - Mapping vulnerability of crops to hazard**
- Need to build capacities of students and users to make use of EOS data and tools for real world applications**



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Thank You

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